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# Magnetics + Mechanics + Nanoscale = Electromagnetic Future

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11-537

Greg P. Carman & OTHERS!!!

Funding : AFOSR, DARPA, NSF ERC Award EEC-1160504





- **IEEE Magnetics Society Home Page:** [www.ieeemagnetics.org](http://www.ieeemagnetics.org)

- 3000 full members
- 300 student members

- **The Society**

- Conference organization (INTERMAG, MMM, TMRC, etc.)
- Student support for conferences
- Large conference discounts for members
- Graduate Student Summer Schools
- Local chapter activities
- Distinguished lectures

- **Journals (Free Electronic Access for Members)**

- *IEEE Transactions on Magnetics*
- *IEEE Magnetics Letters*

- **Online applications for IEEE membership:** [www.ieee.org/join](http://www.ieee.org/join)

- 360,000 members
- IEEE student membership                      IEEE full membership



# GOAL

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- Convince you to work in Nanoscale Multiferroics

## Why

- Future for small scale magnetic devices (1mm > device > 1nm)

## Philosophy

- Innovators (W. Isaacson) – Computers – Critical Mass

## Presentation

- Motivate NOT impress

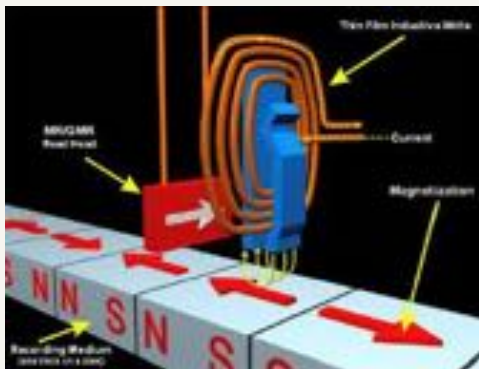


# Outline

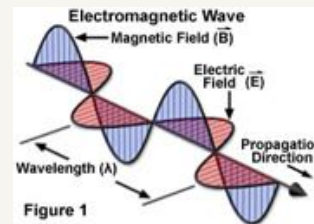
- Motivation – Multiferroic
- Nano-Ellipses (Efficiency/memory)
- Nano-Rings (substrate clamping/motor)
- Superparamagnetic Control (cool stuff)
- Summary

*EM devices are ubiquitous throughout our society*

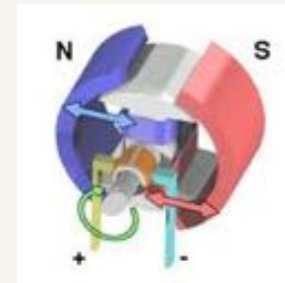
Memory



Antenna



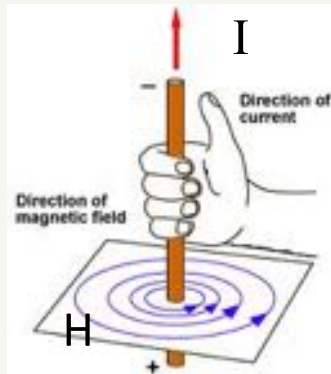
EM Motor



# Why Electrical Control of Magnetism

- 1820 Oersted, H Field generated by current
  - **Problem** - Current/Magnetic field magnitude in the small scale

## EM Devices

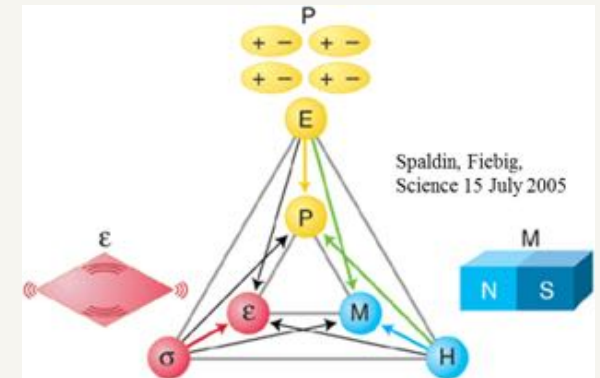
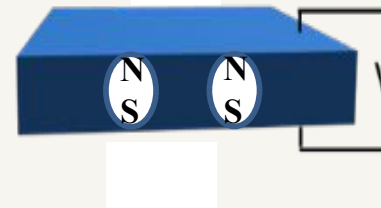


**Magnetic field  $H$   
limited by  
current  $I$**

$H \rightarrow$  1 kOe today

## Multiferroic Illustration

Intrinsic Effect



**Electric field  $E$   
Scales with  
size**



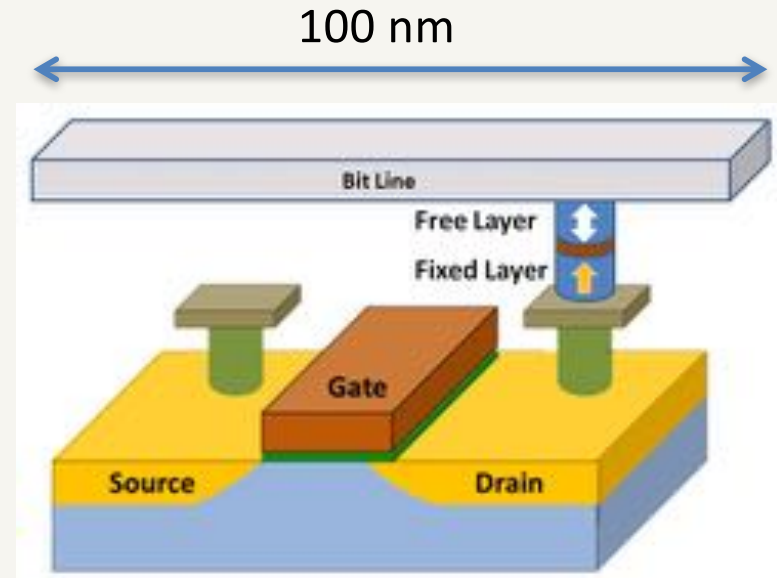
# Efficiencies

## Internal Combustion Engine



Chemical- Mechanical  
 $\eta = 20\%$  Efficient

## STT – MRAM State of the Art



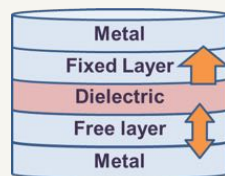
Electrical – Magnetic  
100 fJ to write  
 $\sim 0.3$  aJ barrier

**$\eta = 0.0003\%$  Efficient**



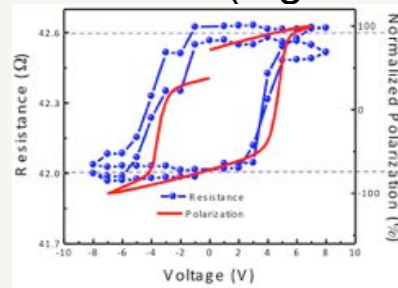
# Types of Multiferroics

- Single phase – Homogeneous material with only one phase most popular is BiFeO(3) –(note antiferromagnetic and ferroelectric)
- Composite – Heterogeneous material system
  - Charge mediated systems- VCMA – test data- [5 fJ](#)



~10nm

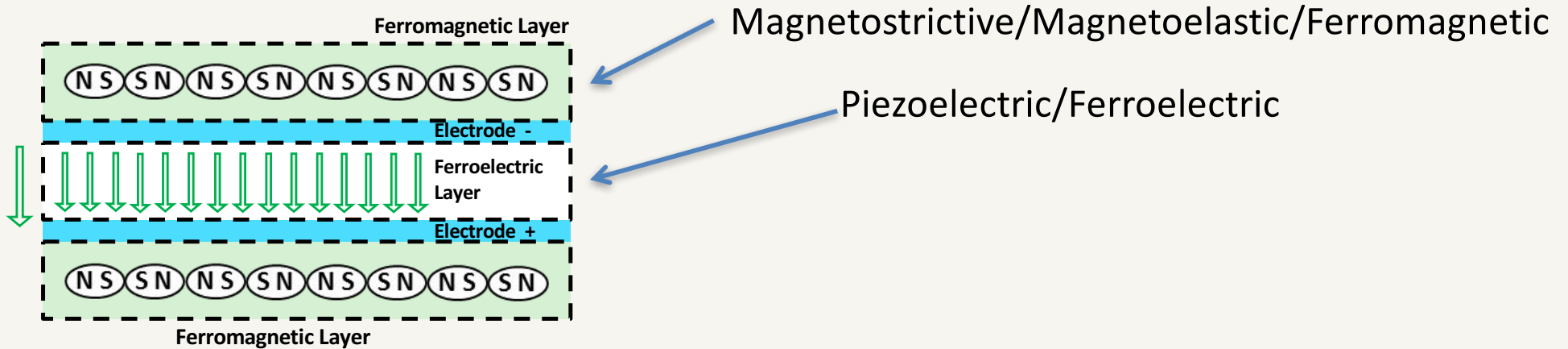
- Exchange coupled– single phase MF + FM (e.g. BFO + CoFe) ~[1fJ](#)



- Strain Mediated systems – Piezoelectric layer (i.e. ferroelectric) + magnetoelastic/magnetostrictive (i.e. ferromagnetic).



# Solution Strain Mediated Multiferroics



Existing Piezo (0.8) + Magnetoelastic (0.8)  
 $= 0.3 \text{ aJ} / (.8 * .8) \quad \sim 1 \text{ aJ}$   
or  $\eta = 60\% \text{ efficient}$

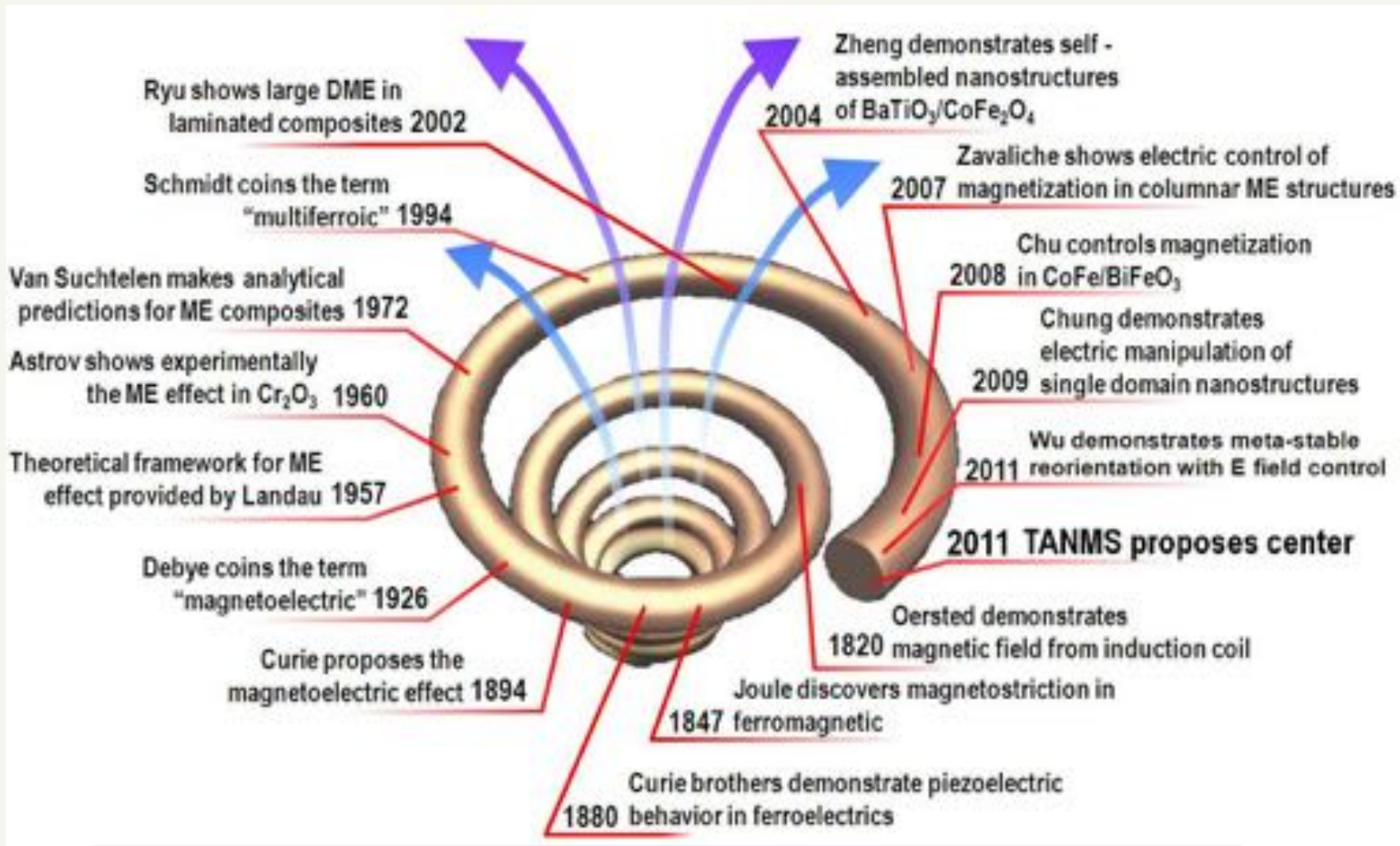
- **Problems Nanoscale**

1. Models ~unavailable
2. Experimental demonstration challenging
3. Substrate clamping problem
4. Why do this? Applications?





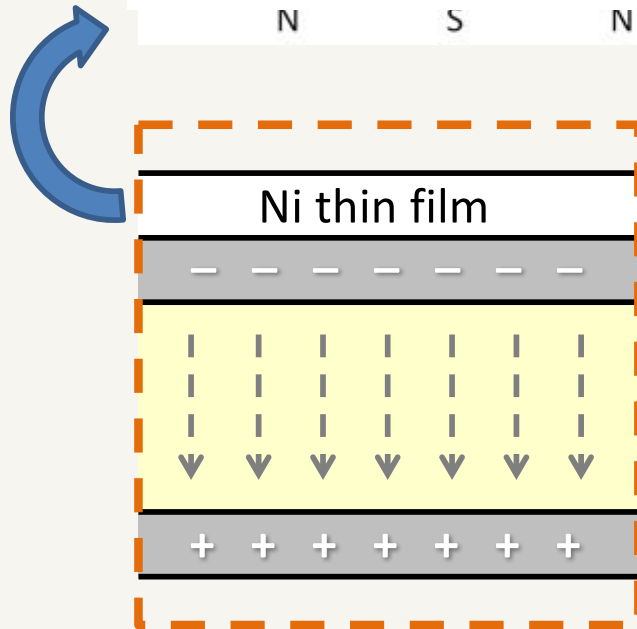
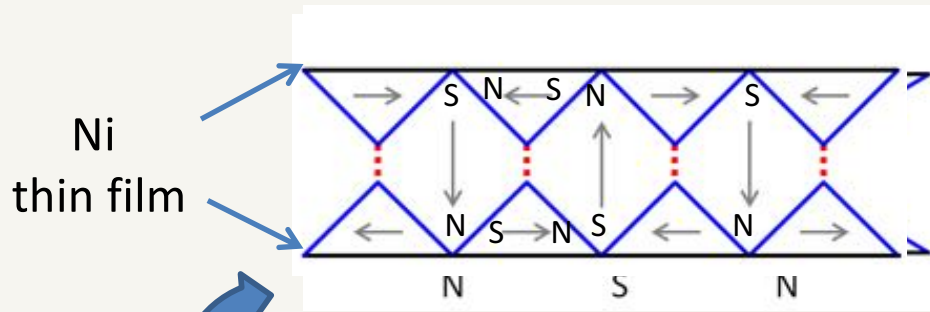
# What has been done?



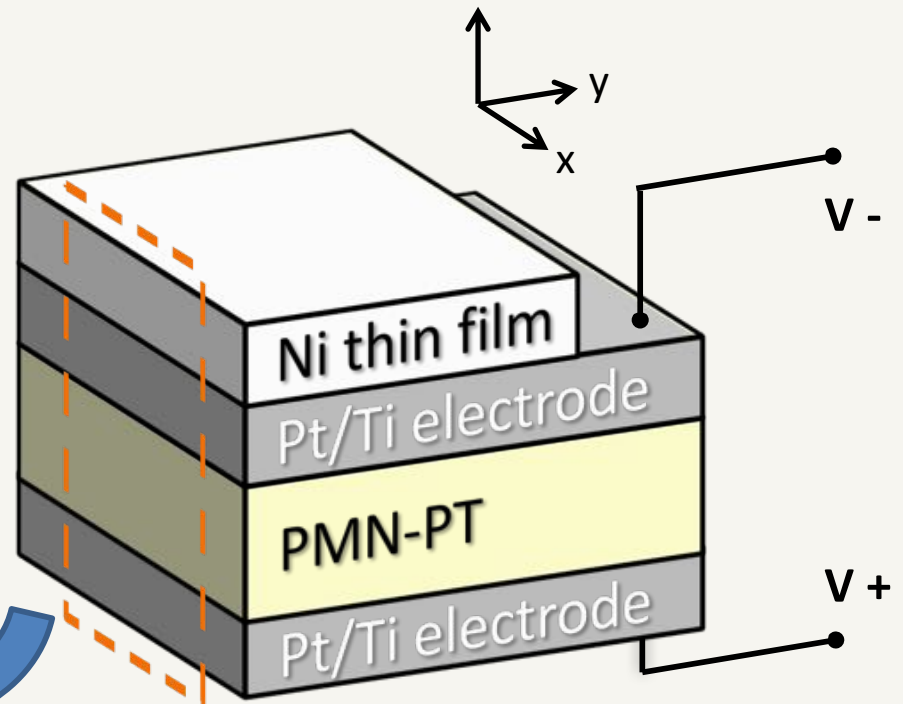
- Bulk multiferroic (DME) >1000 papers
- Thin Film (CME) ~ 100 papers
- Single domain & smaller ~ 10 papers



# Thin Film Multiferroics



- Single crystal piezoelectric PMN-PT
  - Smooth surface
  - Good strain properties/anisotropic
- Ni 30-100nm thin film
  - Magnetoelastic properties good
  - Easy to deposit

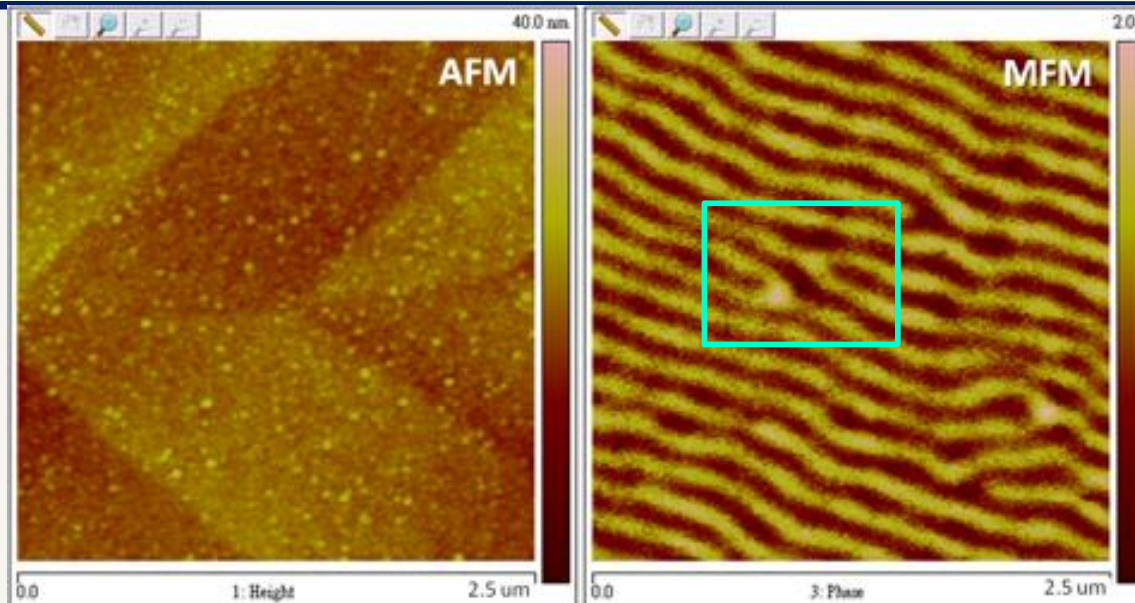


Hsu, Hockel, Carman, Appl. Phys. Lett. V **100**, Issue 9 (2012)

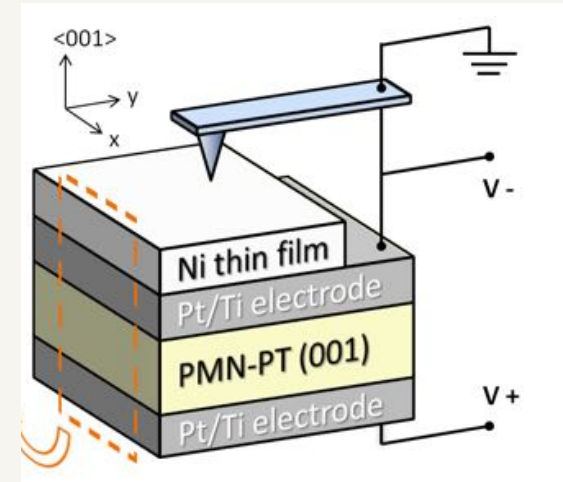
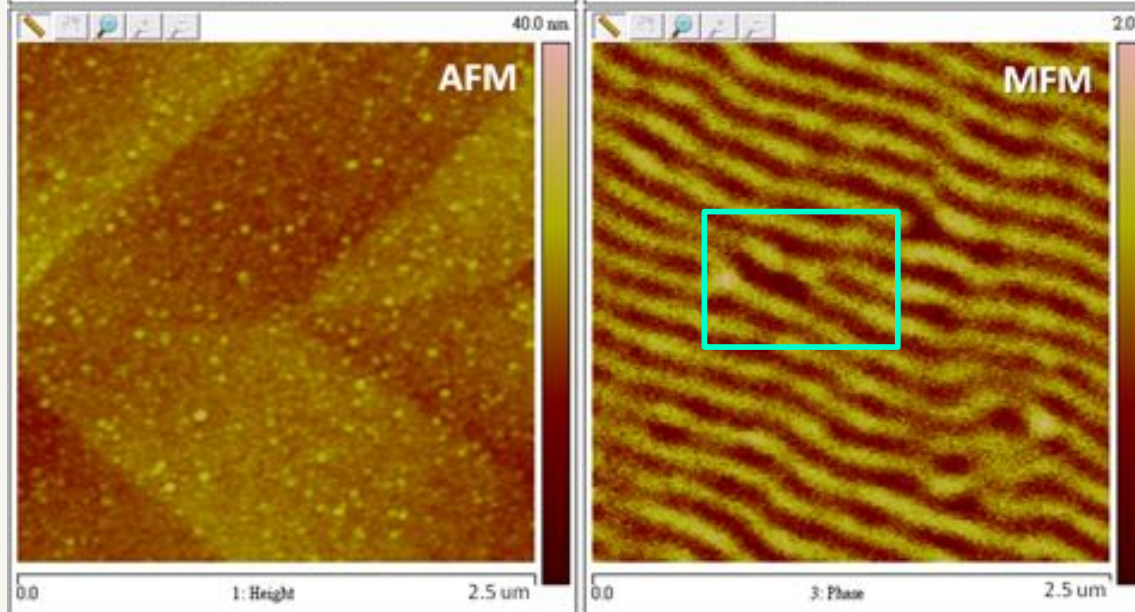


# MFM Imaging 100 nm Ni Film

(0 MV/m)



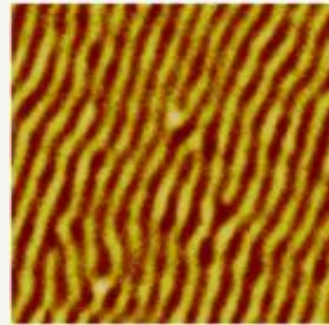
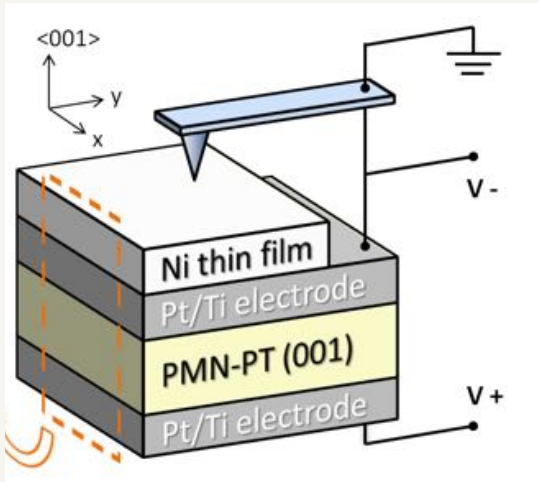
0.8 MV/m



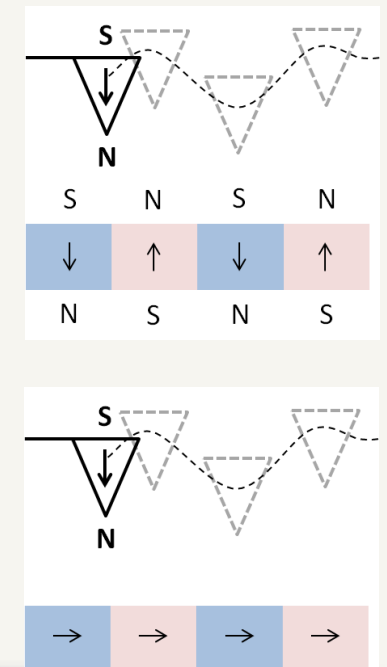
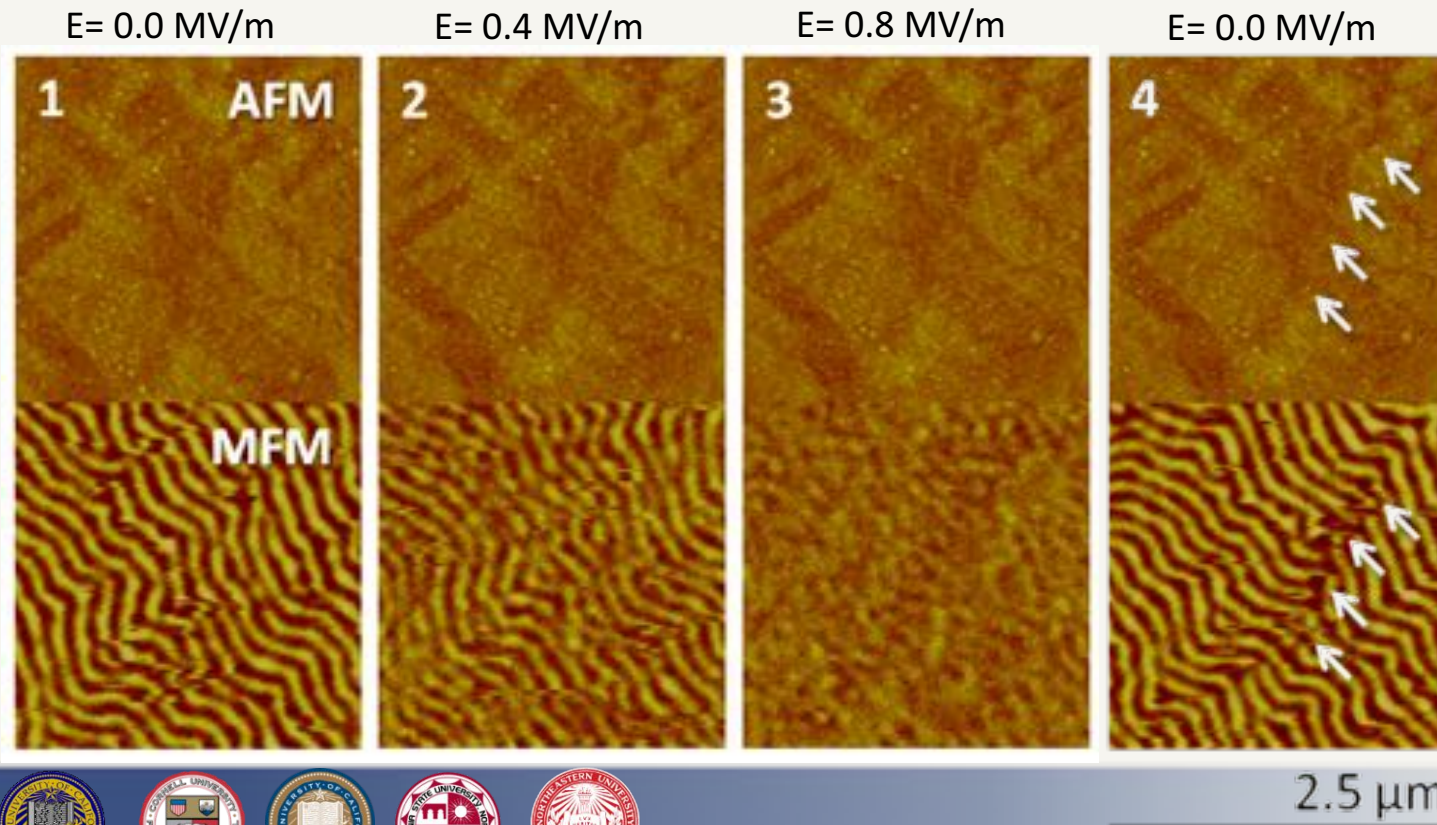
- MFM revealed little change
- Bulk response does change but dependent upon local phenomenon



# MFM Imaging 60 nm Ni Film

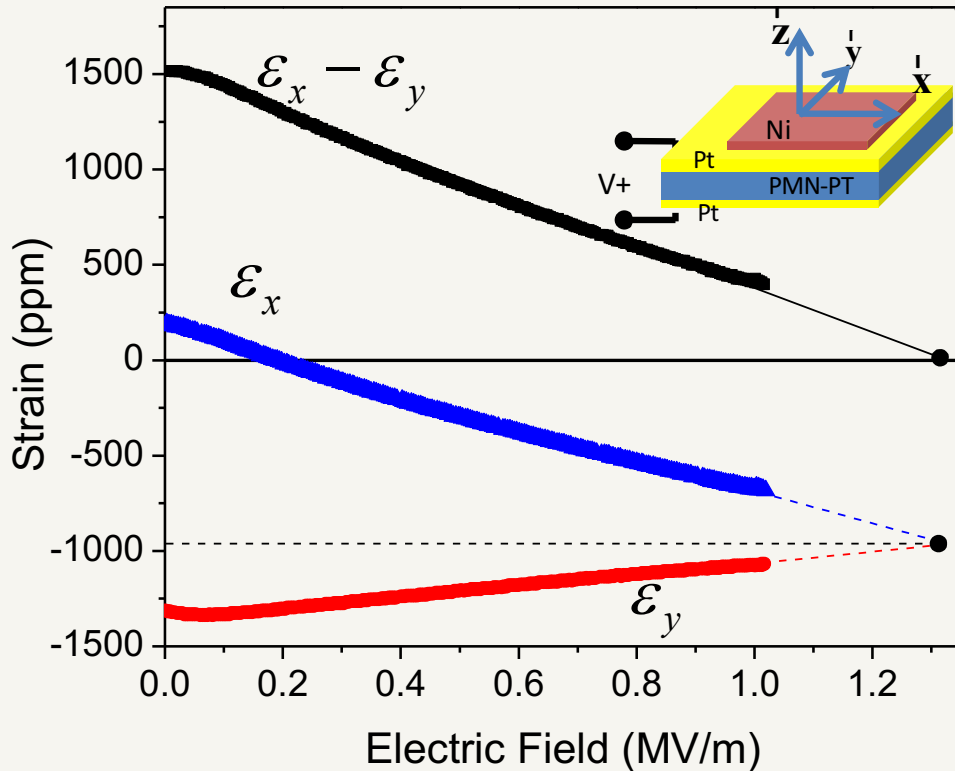


- Thin film (60nm) stripe domains
- Electrical induced transition from Block Wall to Neel wall
- Process is reversible or nonvolatile depending upon PMN-PT and E



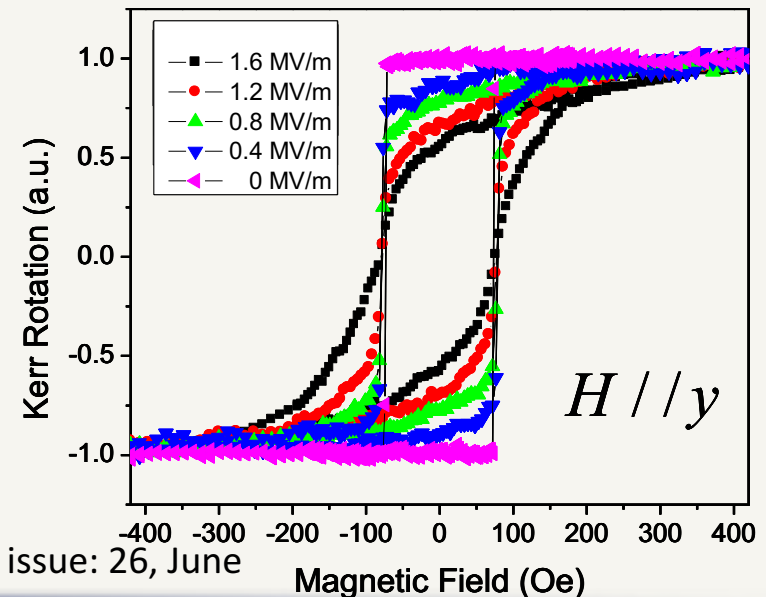
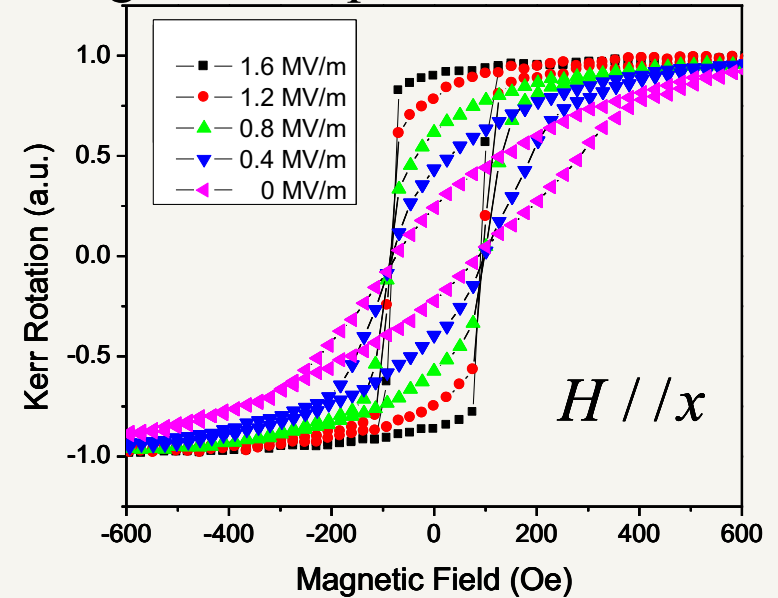
# Voltage Control 35nm Ni Film

Strain Voltage Response  
(011) PMN-PT



- Piezoelectric anisotropic
- Voltage induces magnetic reorientation of sample

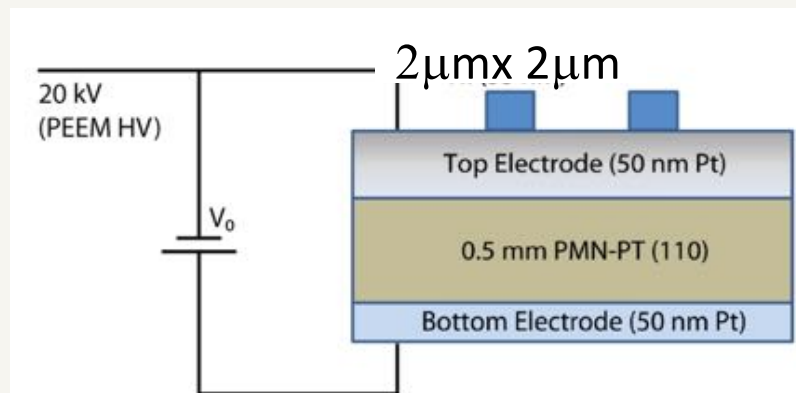
Magnetic Response of Ni Thin Film



Wu, Bur, Wong... Carman, Applied physics letters (2011) volume: 98 issue: 26, June



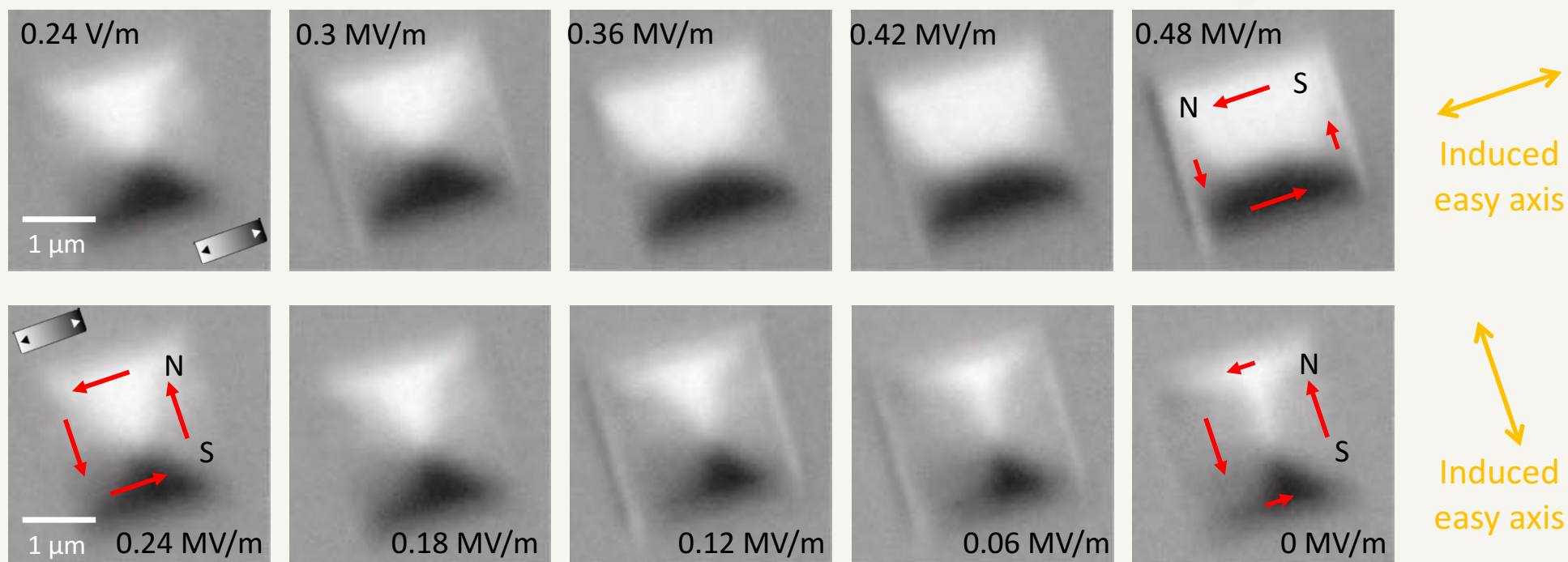
# Control of Micro-Structures



- Ni dots 35 nm thick
- Data shows Neel wall can be manipulated
- Easy axis can be rotated 90 degree, similar to thin film work

Finizio, ...Carman..., Phys. Rev. Applied V1, Issue 2 Mar 2014

PEEM --M. Klaui & Frithjof Nolting et al Johannes Gutenberg & Paul Scherrer



# Modeling Background

- 1687 Newton (elastodynamics)
- 1948 Stoner Wohlfarth
- 1955 Landau-Lifshitz-Gilbert (micromagnetics)
- 2000's LLG + uniform strain (uncoupled) > 50 papers
  - 2001 Zhu, 2006 Hu, 2010 Roy, 2011 Atulasimha, 2011 Bur
- 2000's LLG + elastodynamics (coupled) ~10 paper
  - 2004 Shu Analytical 2D solution
  - 2005 Banas Analytical solution
  - 2005 Chen Numerical solutions
  - 2012 Miehe variational principles
  - 2012 Liang nanoscale single domain –UCLA ~4 papers

## Elastodynamics

$$\nabla \cdot \underline{\underline{\tilde{\sigma}}} + \underline{\underline{f}} = \rho \underline{\underline{\ddot{u}}}$$

$$\underline{\underline{\tilde{\sigma}}} = \underline{\underline{C}} \underline{\underline{\varepsilon}}$$

$$\underline{\underline{f}} = -\nabla \cdot \left[ \underline{\underline{C}} \underline{\underline{\varepsilon}}^m - \underline{\underline{C}} d\underline{\underline{E}} \right]$$

## Landau-Lifshitz-Gilbert Equation

$$\frac{\partial \underline{\underline{M}}}{\partial t} = -\mu_0 \gamma \underline{\underline{M}} \times \underline{\underline{H}}_{\text{eff}} + \frac{\alpha}{M} \underline{\underline{M}} \times \frac{\partial \underline{\underline{M}}}{\partial t}$$

$$\underline{\underline{H}}_{\text{eff}} = -\frac{1}{\mu_0 M_S} \frac{\partial E_{\text{tot}}}{\partial \underline{\underline{m}}} = \underline{\underline{H}}_{\text{ext}} + \underline{\underline{H}}_{\text{ex}} + \underline{\underline{H}}_{\text{ms}} + \underline{\underline{H}}_{\text{el}} + \underline{\underline{H}}_{\text{me}}(\underline{\underline{m}}, \underline{\underline{u}}(E))$$



# Modeling Coupled System of Equations

## Landau-Lifshitz-Gilbert Equation

$$\frac{\partial \underline{M}}{\partial t} = -\mu_0 \gamma \underline{M} \times \underline{H}_{eff} + \frac{\alpha}{M} \underline{M} \times \frac{\partial \underline{M}}{\partial t}$$

$$\underline{H}_{eff} = -\frac{1}{\mu_0 M_S} \frac{\partial E_{tot}}{\partial \underline{m}} = \underline{H}_{ext} + \underline{H}_{ev} + \underline{H}_{anis} + \underline{H}_d + \underline{H}_{mv}(\underline{m}, \underline{u}(E))$$

## Elastodynamics

$$\nabla \cdot \underline{\underline{\tilde{\sigma}}} + \underline{f} = \rho \underline{\underline{\ddot{u}}}$$

$$\underline{\underline{\tilde{\sigma}}} = \underline{\underline{C}} \underline{\underline{\varepsilon}}$$

$$\underline{f} = -\nabla \cdot \left[ \underline{\underline{C}} \underline{\underline{\varepsilon}}^m - \underline{\underline{C}} d \underline{E} \right]$$

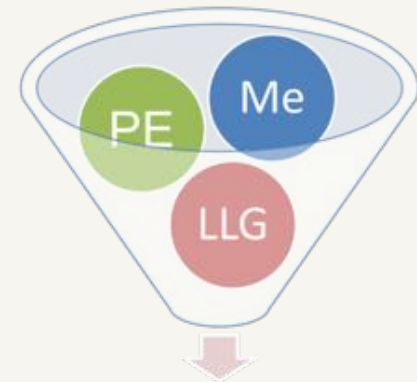
## Piezoelectric effect (electrostatic)

$$\nabla \cdot \underline{D} = 0$$

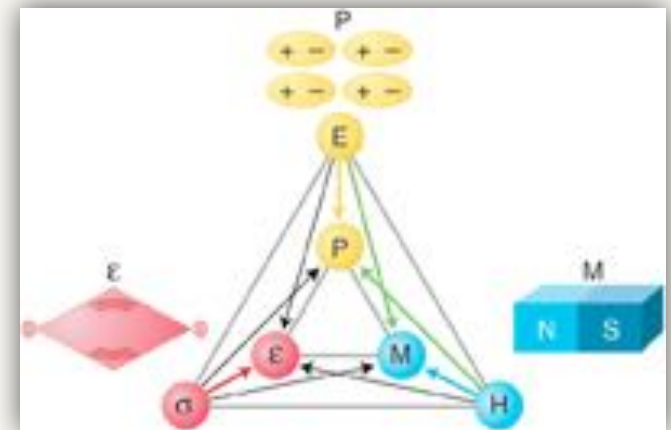
$$\underline{E} = -\nabla V$$

$$S_{ij} = s_{ijkl}^E T_{kl} + d_{ijk} E_k$$

$$D_{ij} = d_{ijk} T_{kl} + s_{ik}^T E_k$$



COUPLED SYSTEM



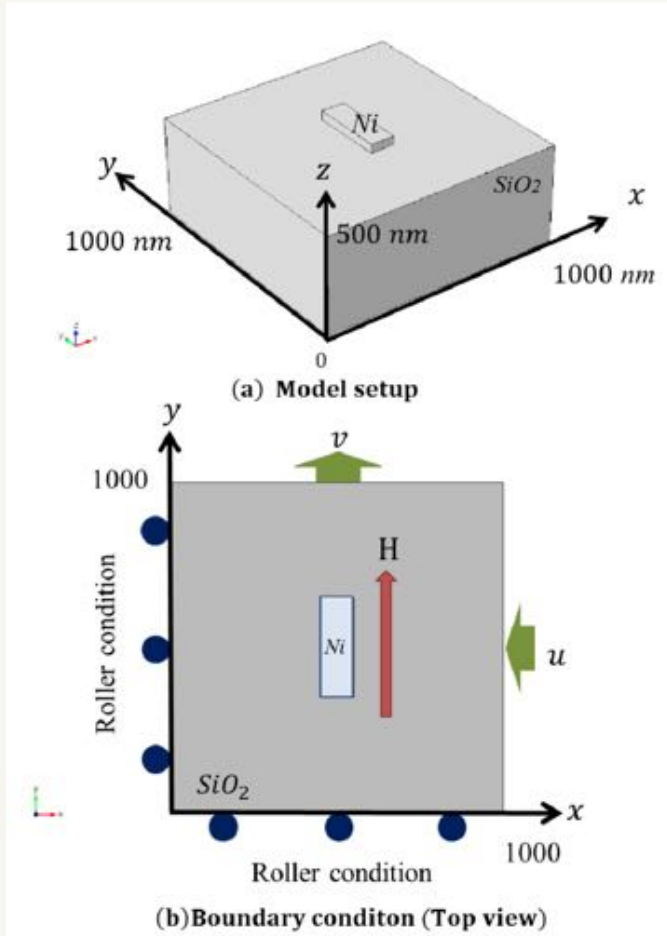
- Equations of LLG, piezoelectric effect and elastodynamics are a system of coupled partial differential equations
- Total equal 7 coupled PDE + 4 coupled PDE.



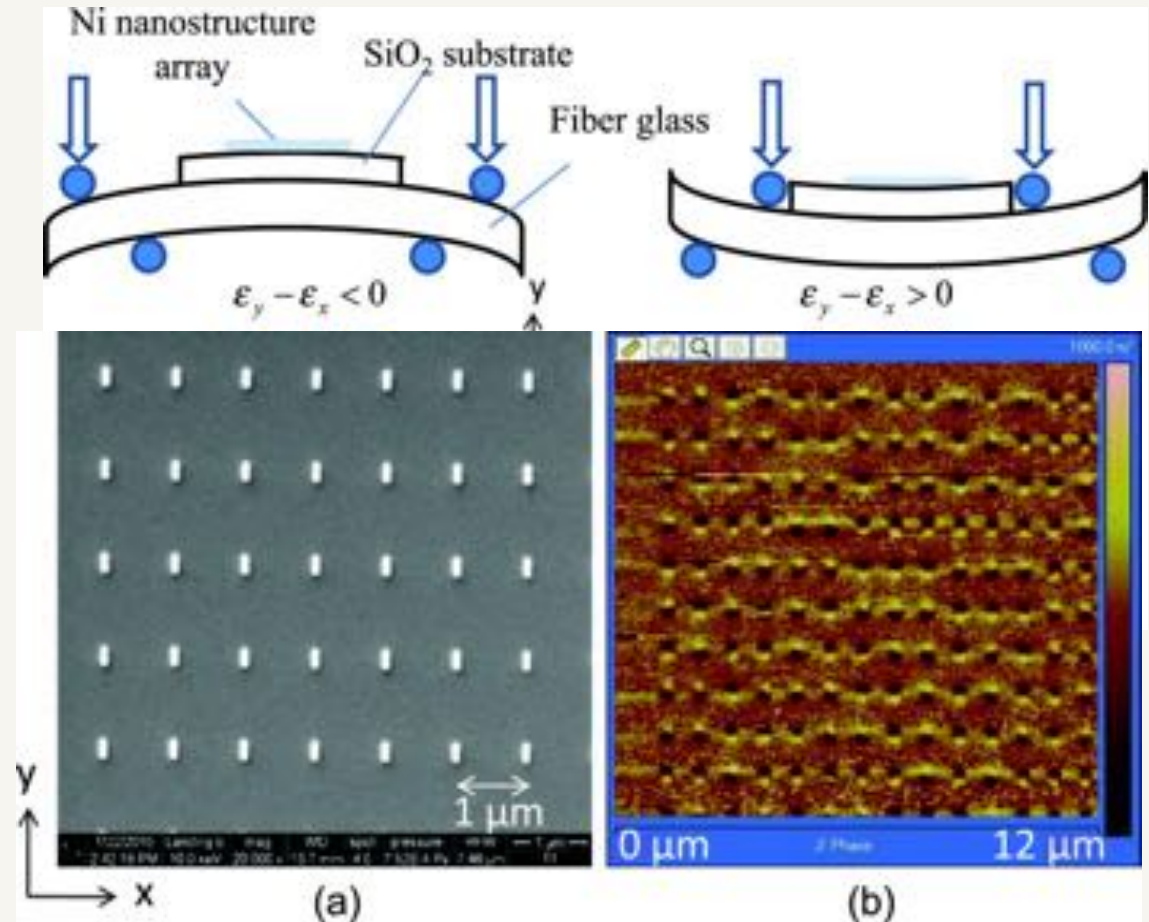


# Analytical & Experimental Setup

- (a) Element size  $\sim$  exchange length 7 nm
- (b) Coupled model
- (c)  $M, H, \epsilon, \sigma$  spatially vary



- (a) Ni magnetoelastic material 300 x 100 nm
- (b) Array of nanostructures
- (c) MOKE measurements



Bur, ... Carman,, JOURNAL OF APPLIED PHYSICS, Vol 109 Iss: 12, JUN 2011



# Quantitative Agreement Exp & Models

Stoner–Wohlfarth model

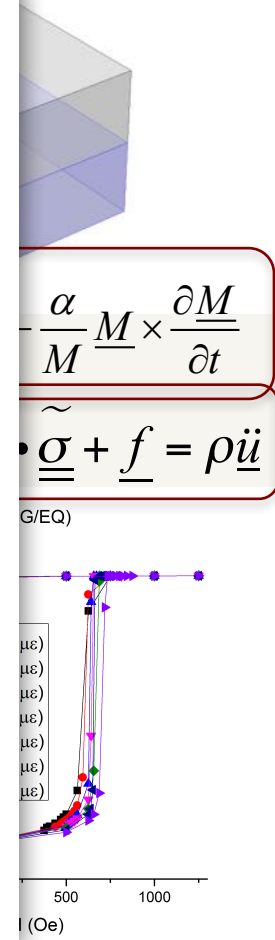
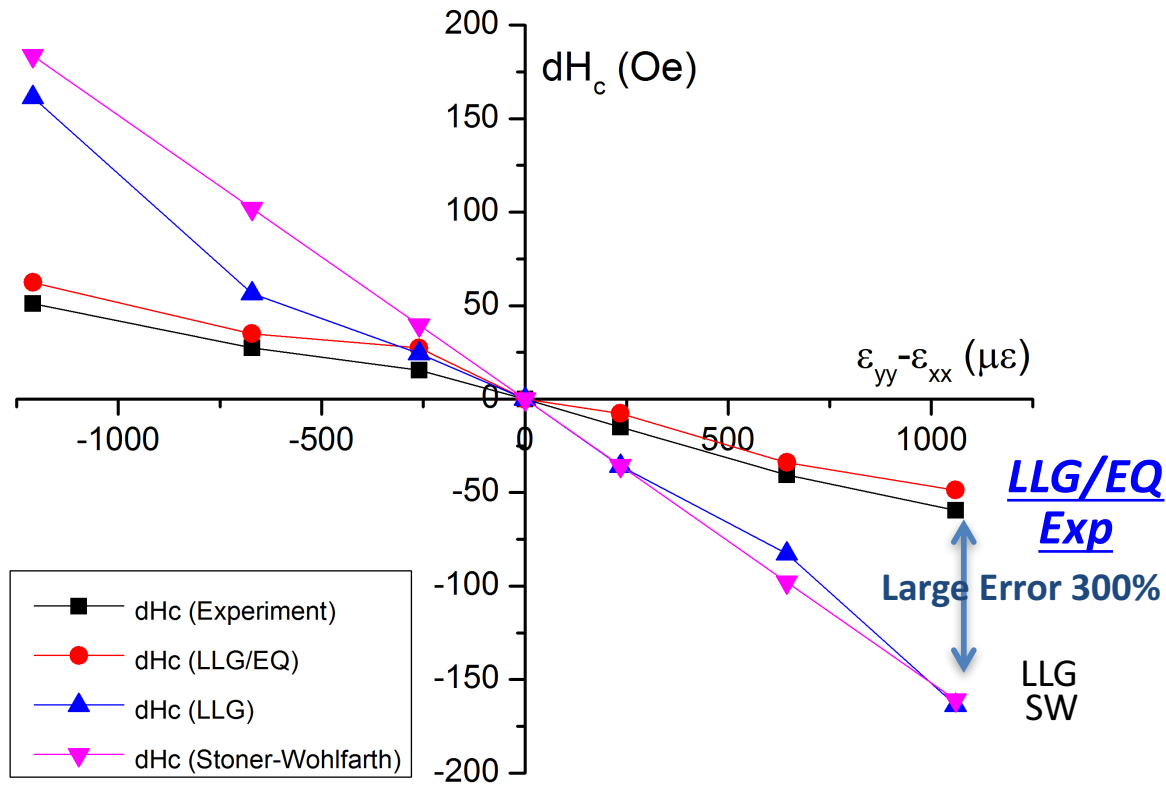
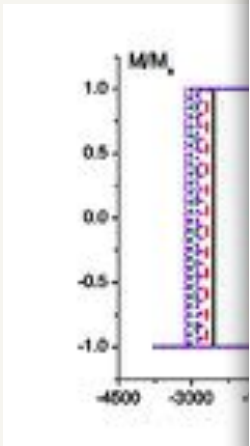
LLG model

LLG/EQ model

(Un

n Strain)

$$E = K_u V \sin^2(\phi)$$



$$\frac{\alpha}{M} \underline{M} \times \frac{\partial \underline{M}}{\partial t}$$

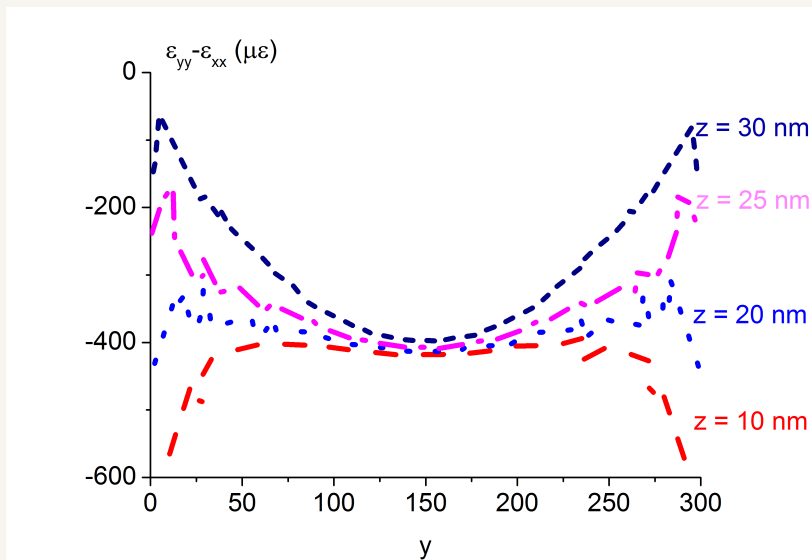
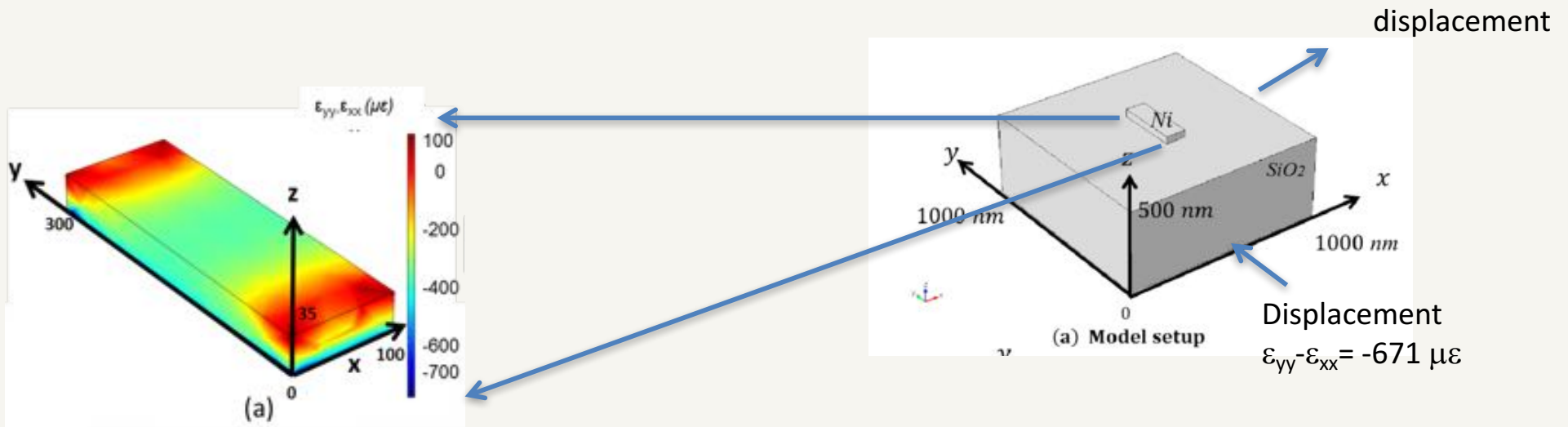
$$\underline{\sigma} + \underline{f} = \rho \underline{\ddot{u}}$$

The LLG/EQ model good agreement **less than 2% error**  
 Stoner-Wohlfarth model and the LLG model **as much as 300% error.**

JAP + App Phy Rev



# Shear Lag Dependence



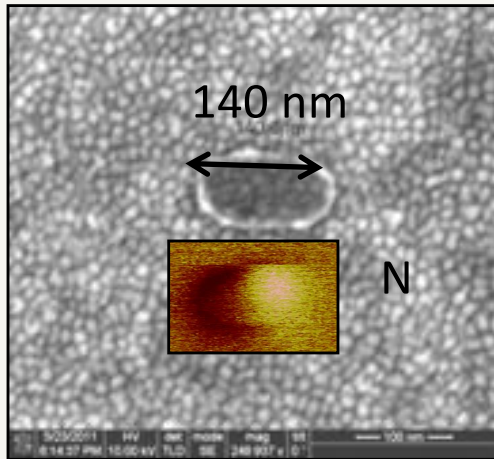
- Stress/strain distribution is non-uniform
- M/H distribution is non-uniform.
- Constant strain present is inappropriate for this structure..

Liang , ... Carman, NANOTECHNOLOGY, Vol 25 Iss 43, OCT 31 2014

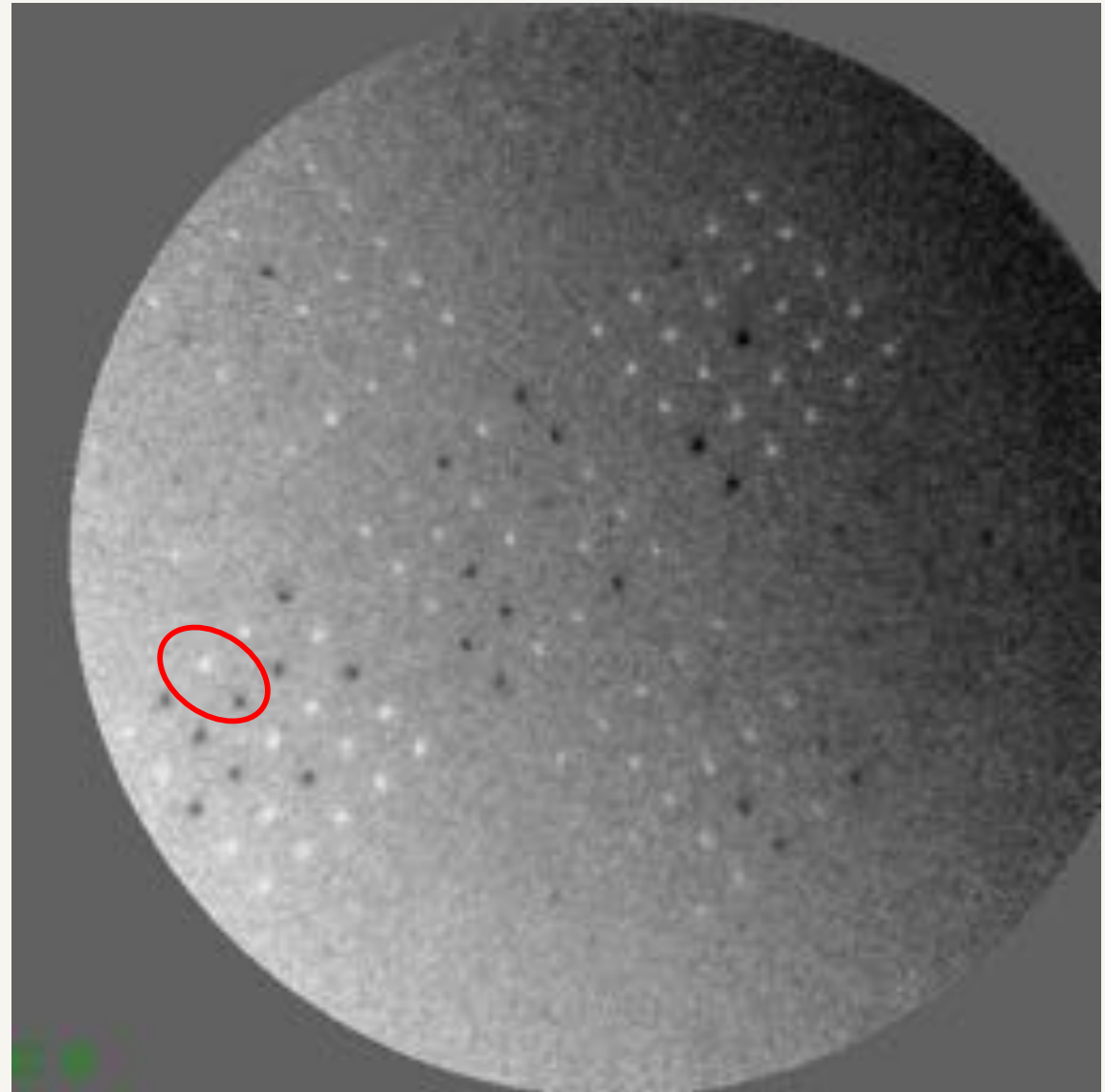
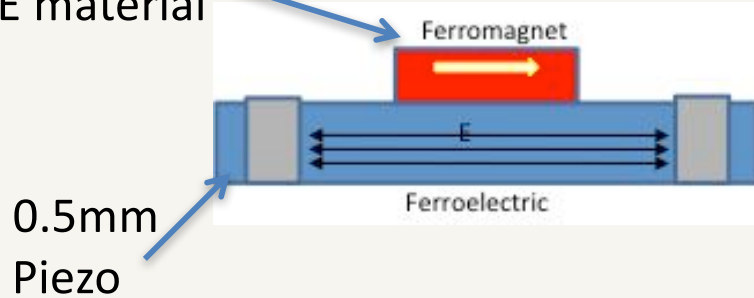


# Single Domain PEEM

Experimentally confirmed Nolting Paul Scherrer Inst



15nm  
ME material



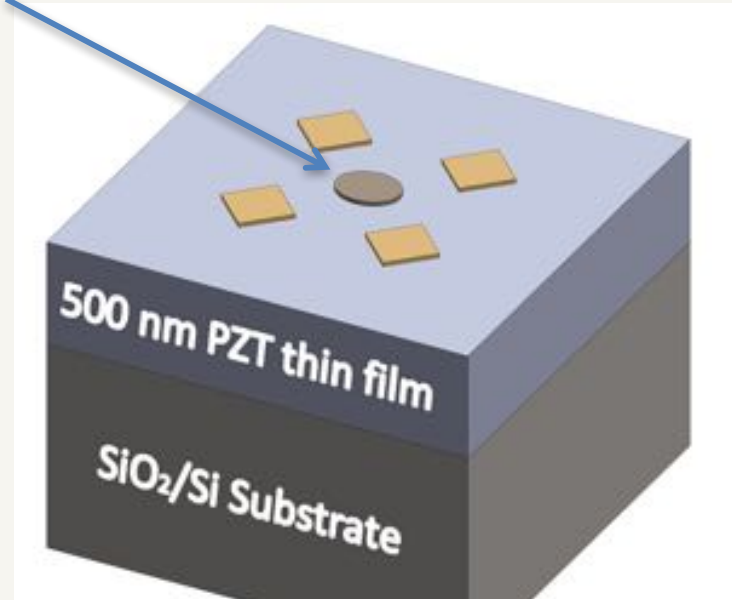
Buzzi ,... Carman, PHYSICAL REVIEW LETTERS Vol 111 Iss: 2, JUL 9 2013

Energy = 10fJ ***NOT better***

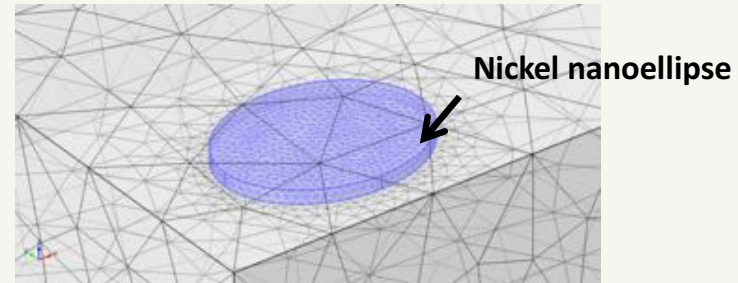


# Substrate Clamping Problem

Ni Ellipse disk size: 150-120-10 (nm)

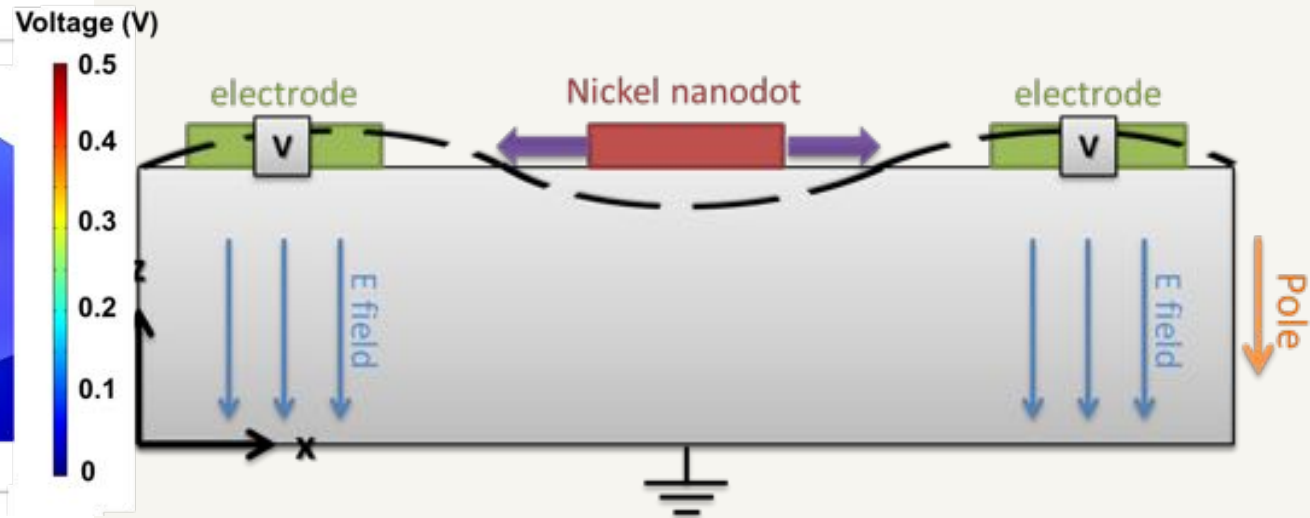
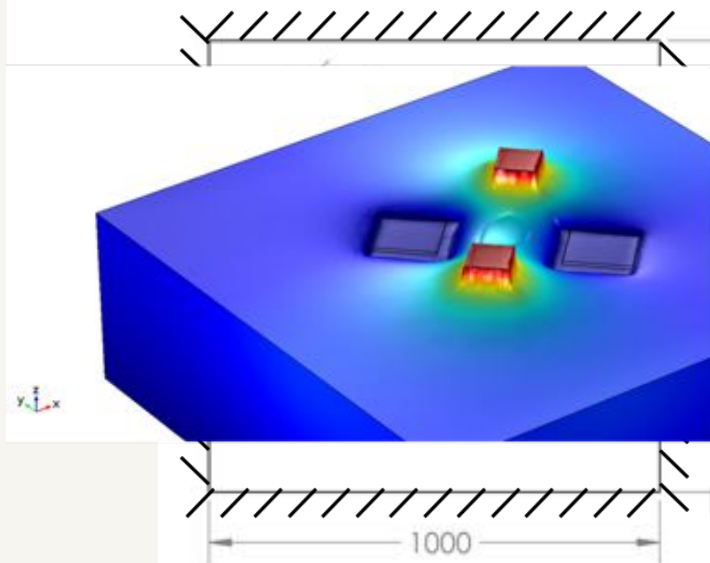


## Simulation Setup:



Mesh size is on the order of exchange length

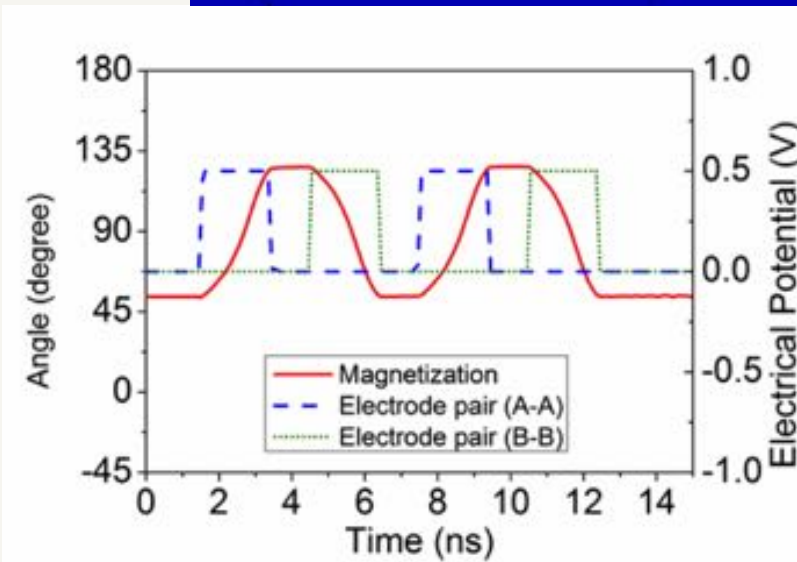
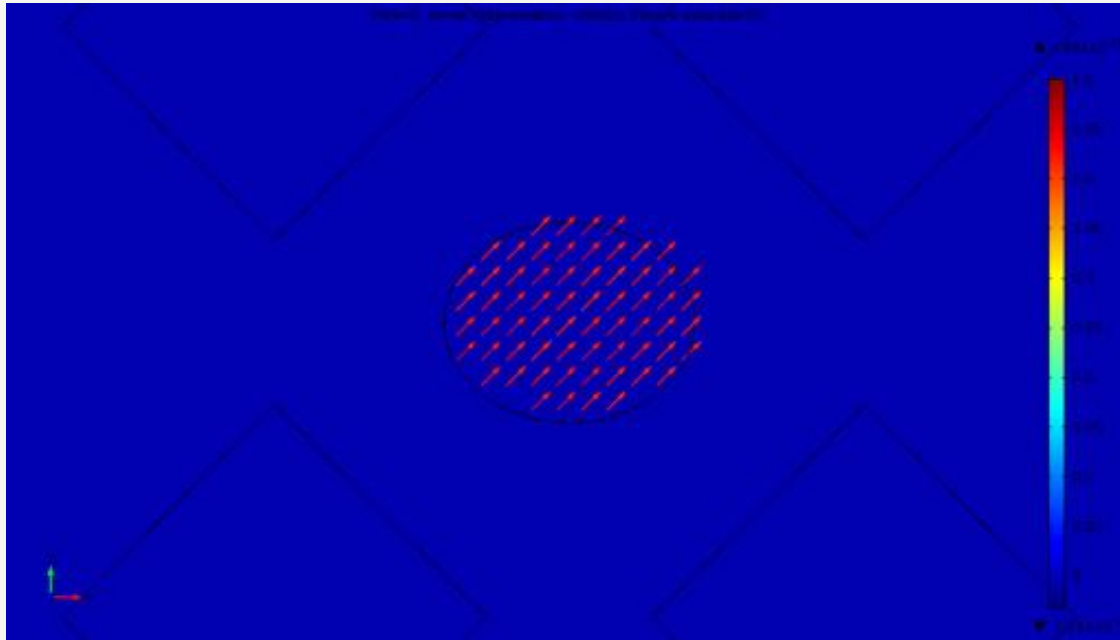
Cui, Lynch, .. Carman, APL, V 103, Is 23, 2013



*All four boundaries are clamped*



# Simulation Results



**Write Energy = 0.3 fJ**  
**TD = 0.08 fJ or 80 aJ**  
**Optimized = 10 aJ**

# Magnetic states in micron-scale rings (stator)

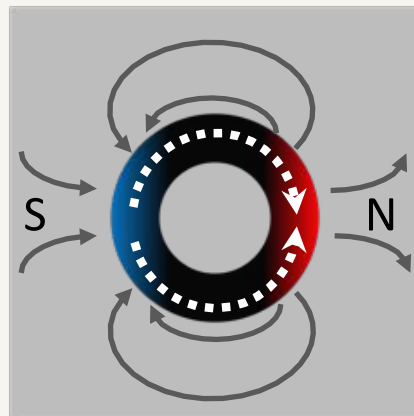
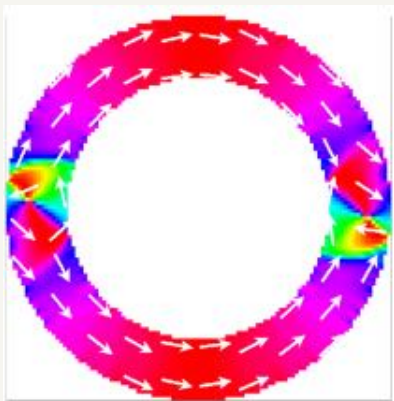
Red Blood Cell



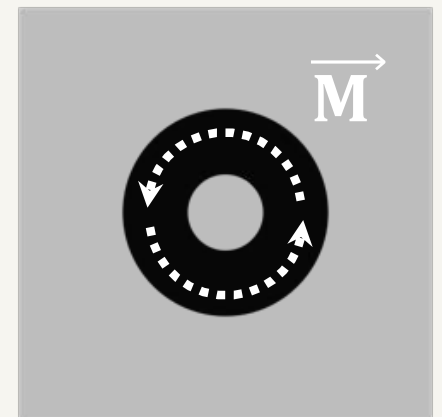
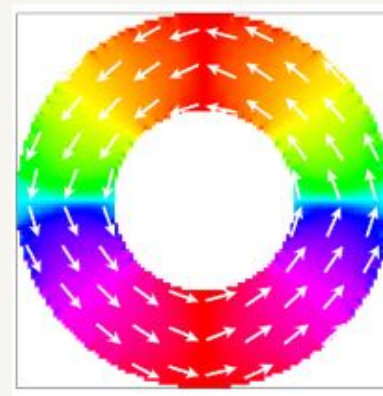
Magnetic state

- Onion state
- Vortex state

Onion state



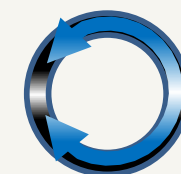
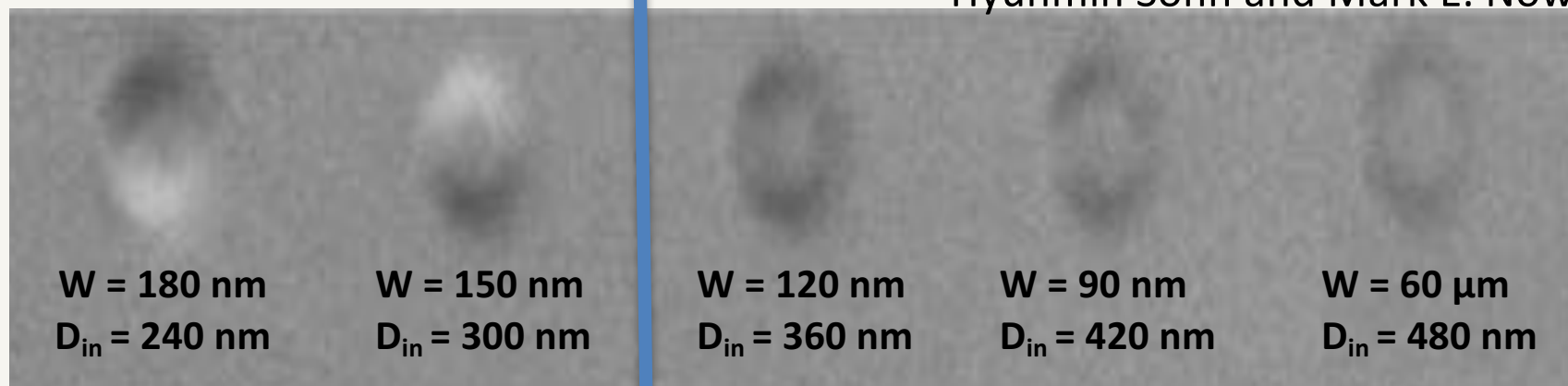
Vortex state



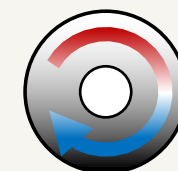
# Simulation vs. Experiment (cont'd)

## Experimental (PEEM) Results

Hyunmin Sohn and Mark E. Nowakowski, 2014



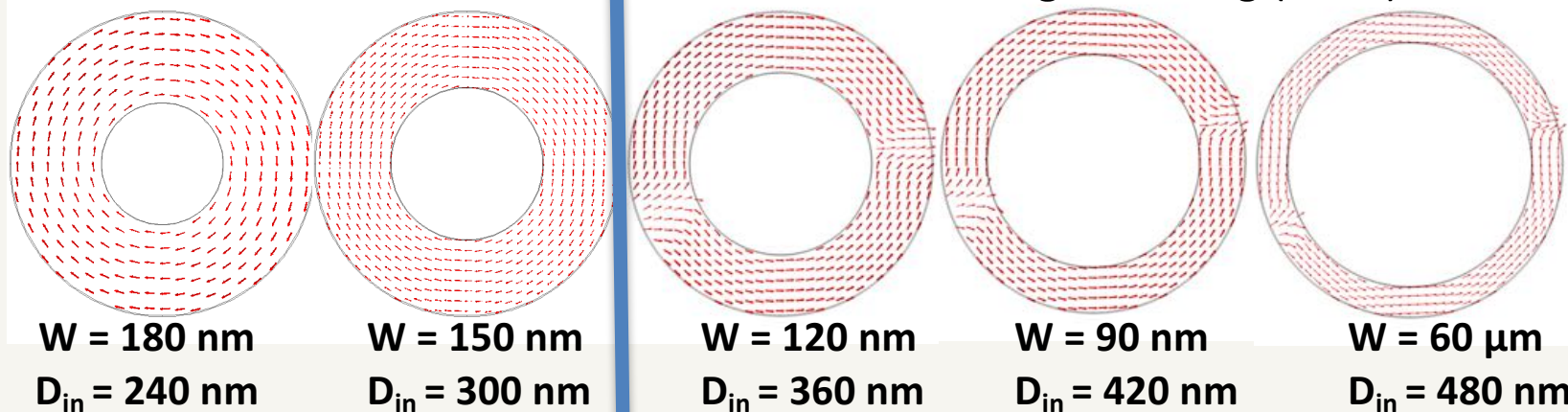
Onion state



Vortex state

## Simulation Results

Outer diameter 600 nm  
Cheng-Yen Liang (2014)

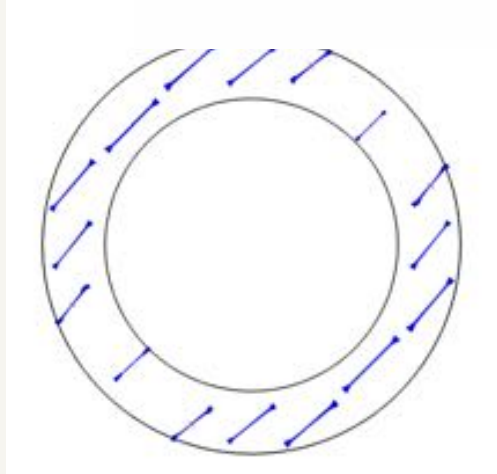
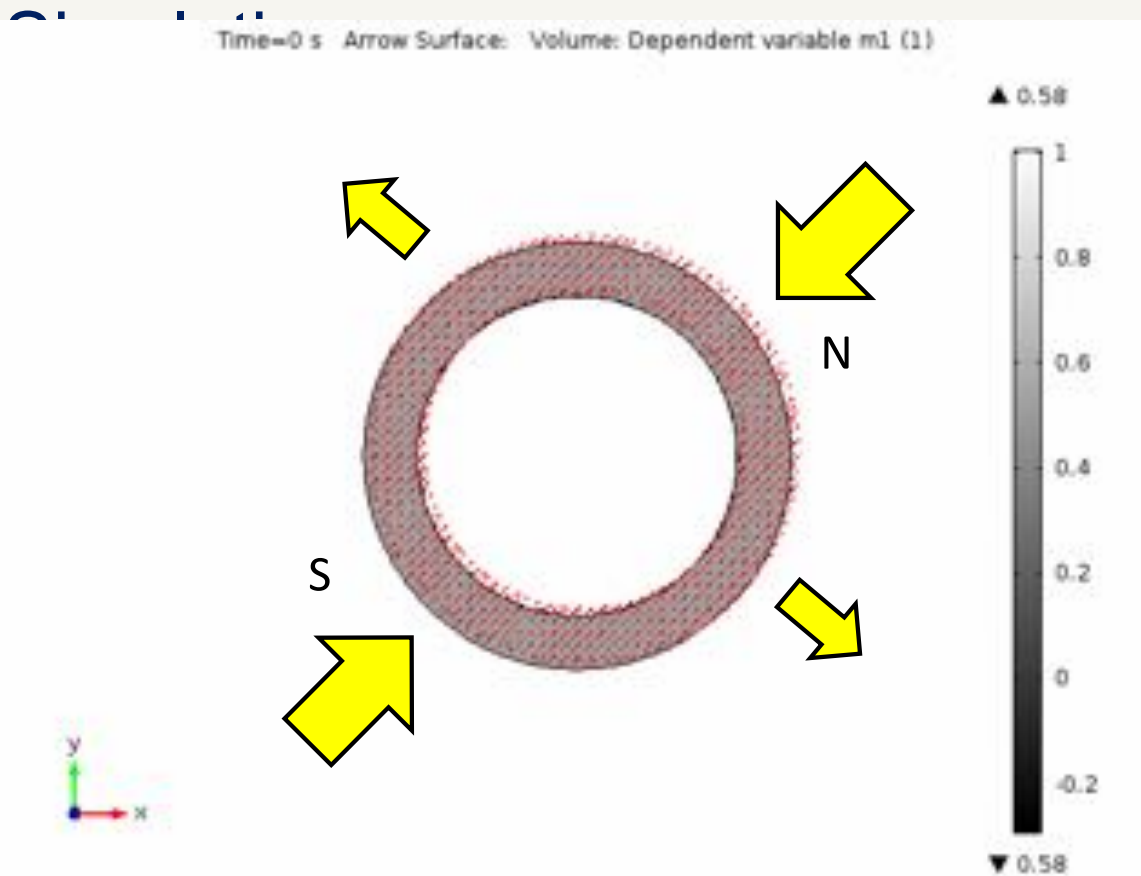
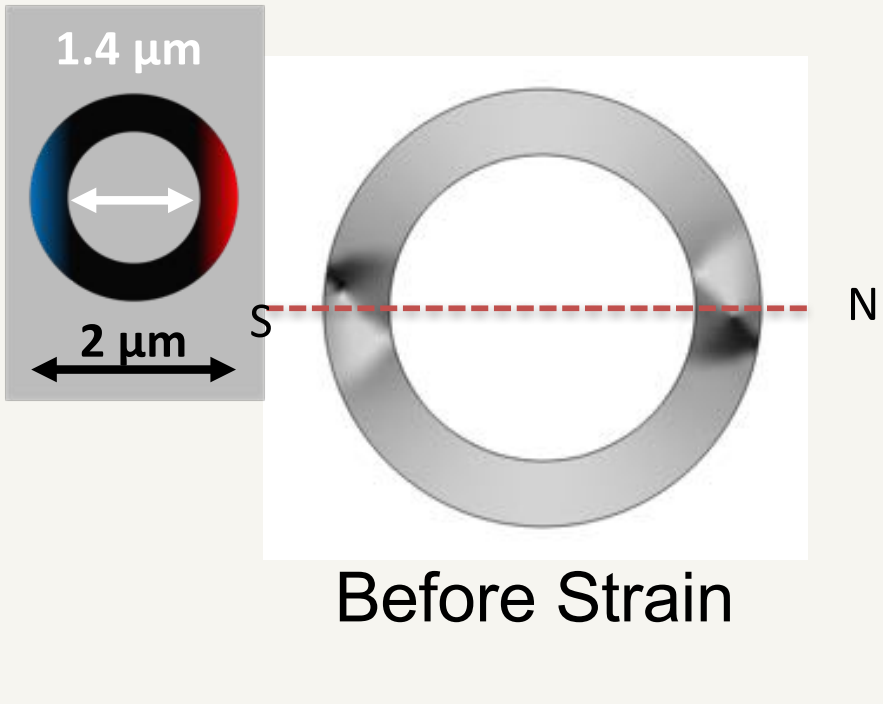


Sohn, Nowakowski, ... Carman, ACS NANO, Vol: 9 Issue: 5 MAY 2015





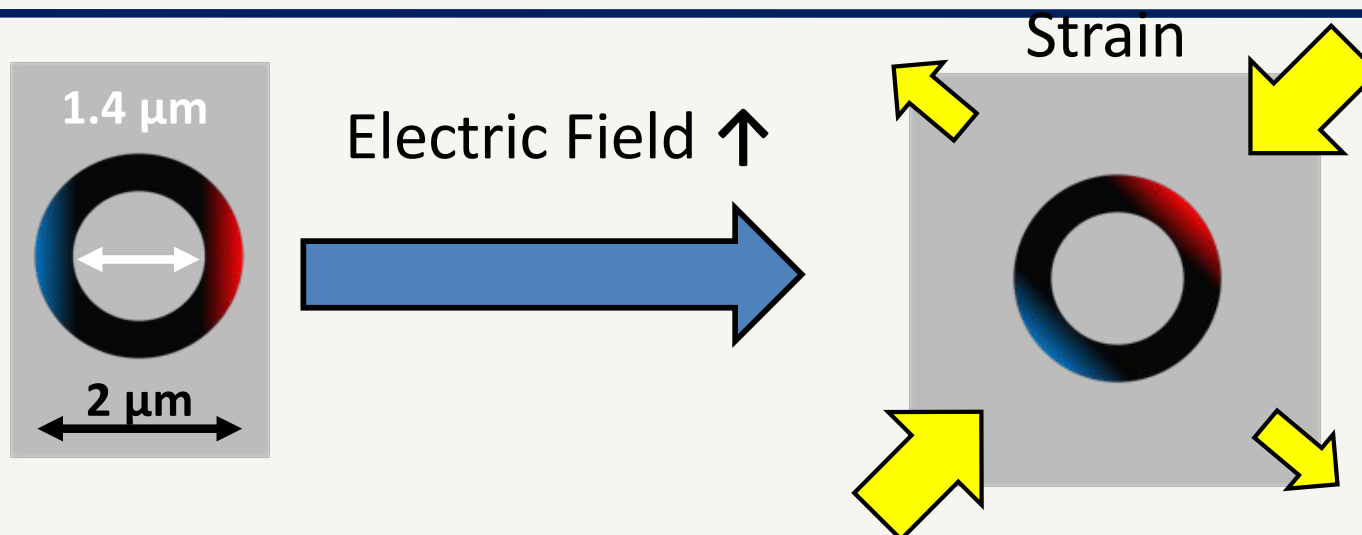
# Modeling



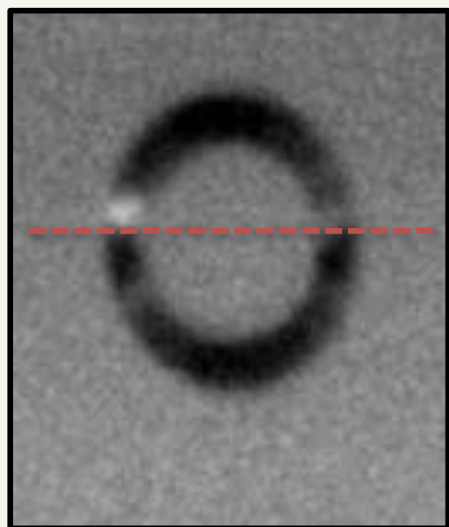
Principal stress direction



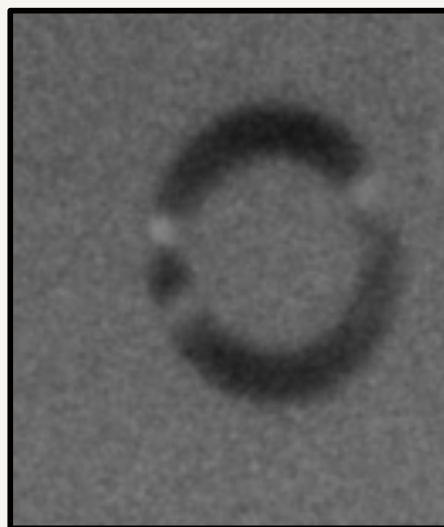
# 45° Rotation PEEM Data



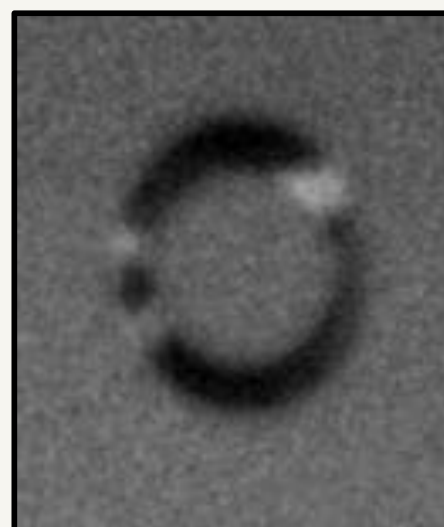
PEEM with increasing Electric Field



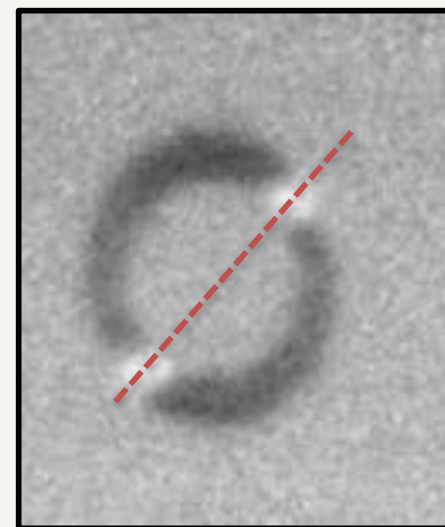
0 MV/m



0.4 MV/m



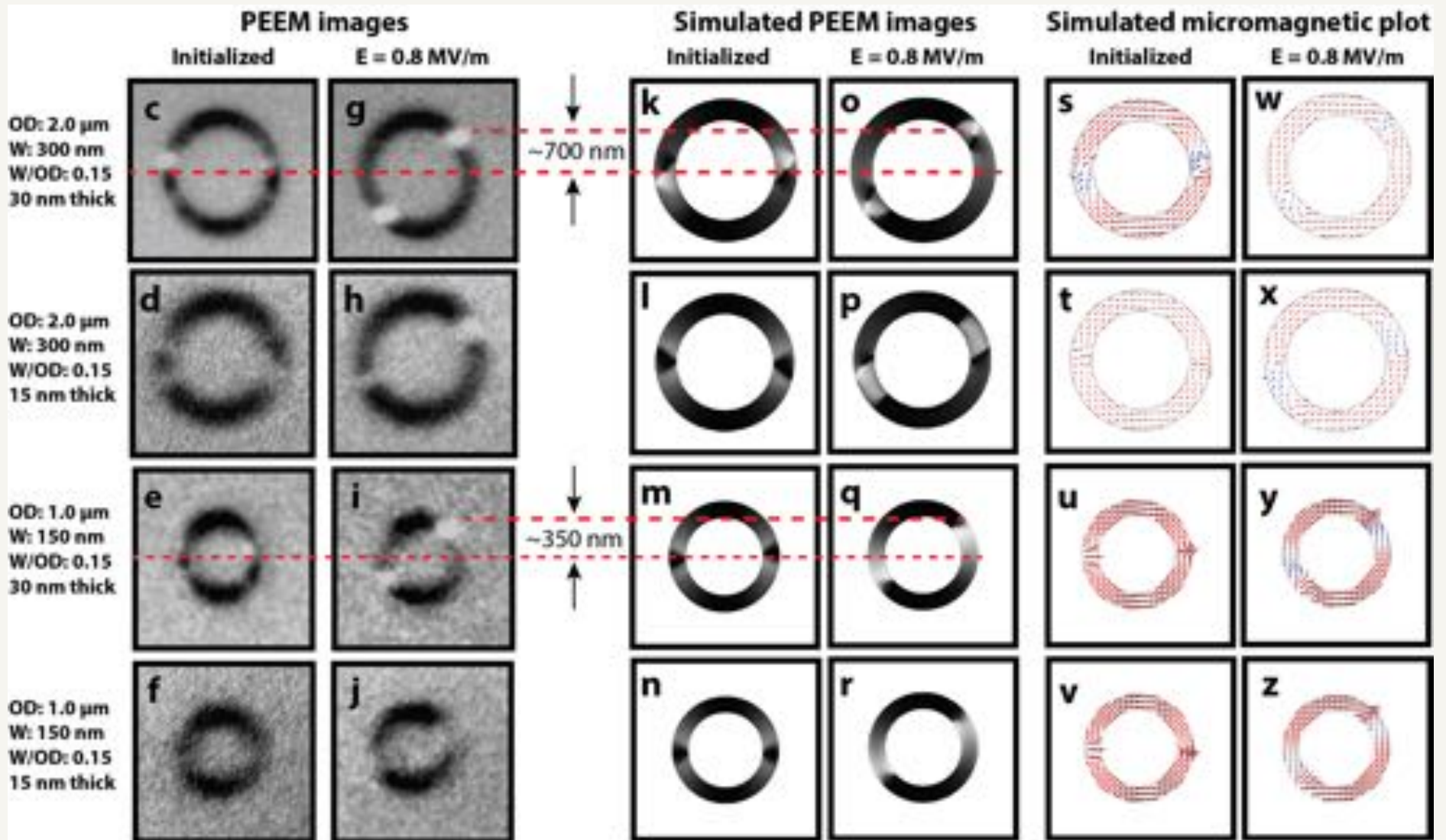
0.44 MV/m



0.52 MV/m

*First Demonstration of **Deterministic** Onion State Rotation in Nanoscale Multiferroic Rings!*

# Analytical vs Experimental AGREEMENT



Sohn, Nowakowski, ... Carman, ACS NANO, Vol: 9 Issue: 5 MAY 2015

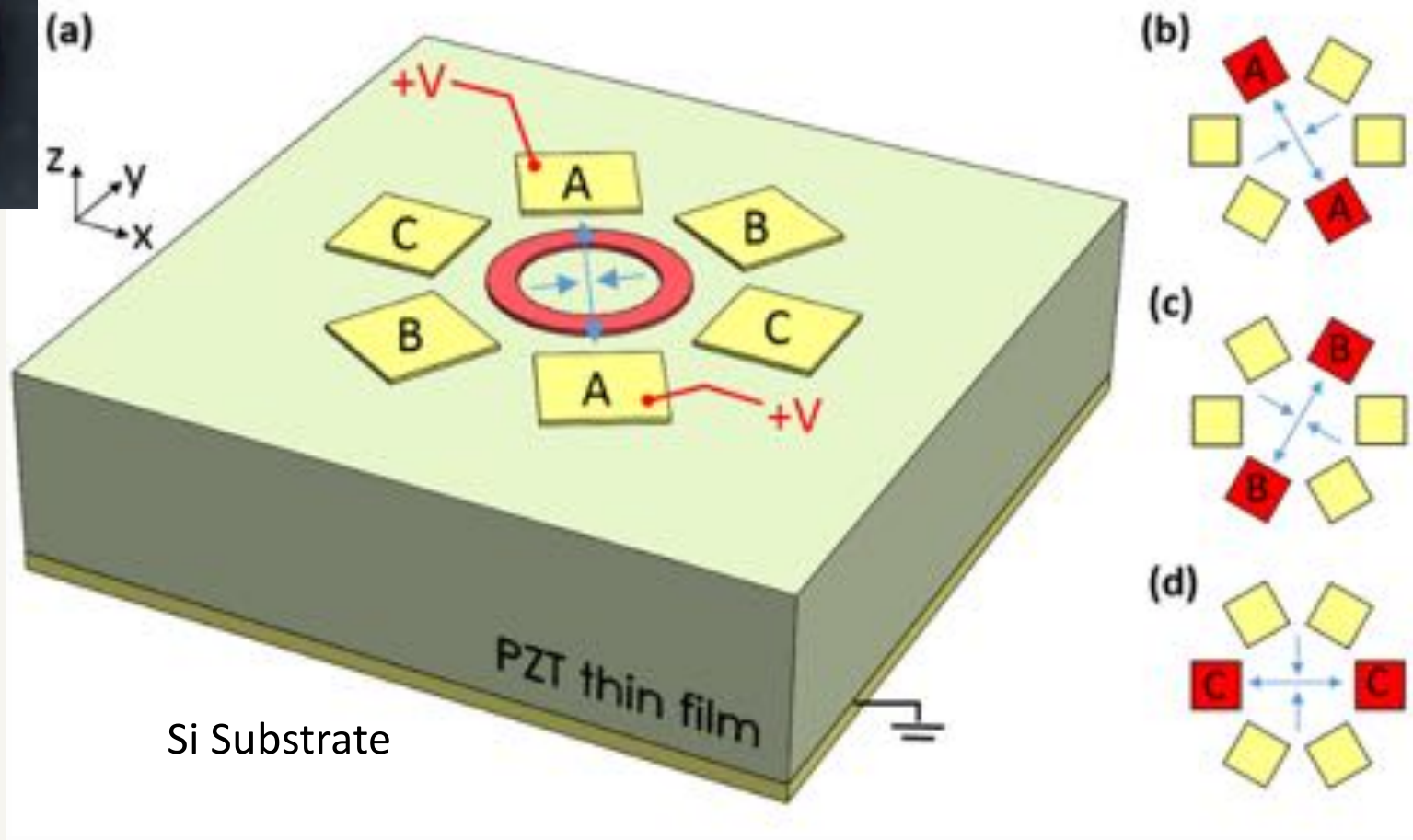


# Surface Electrodes on Thin Film Ferroelectrics

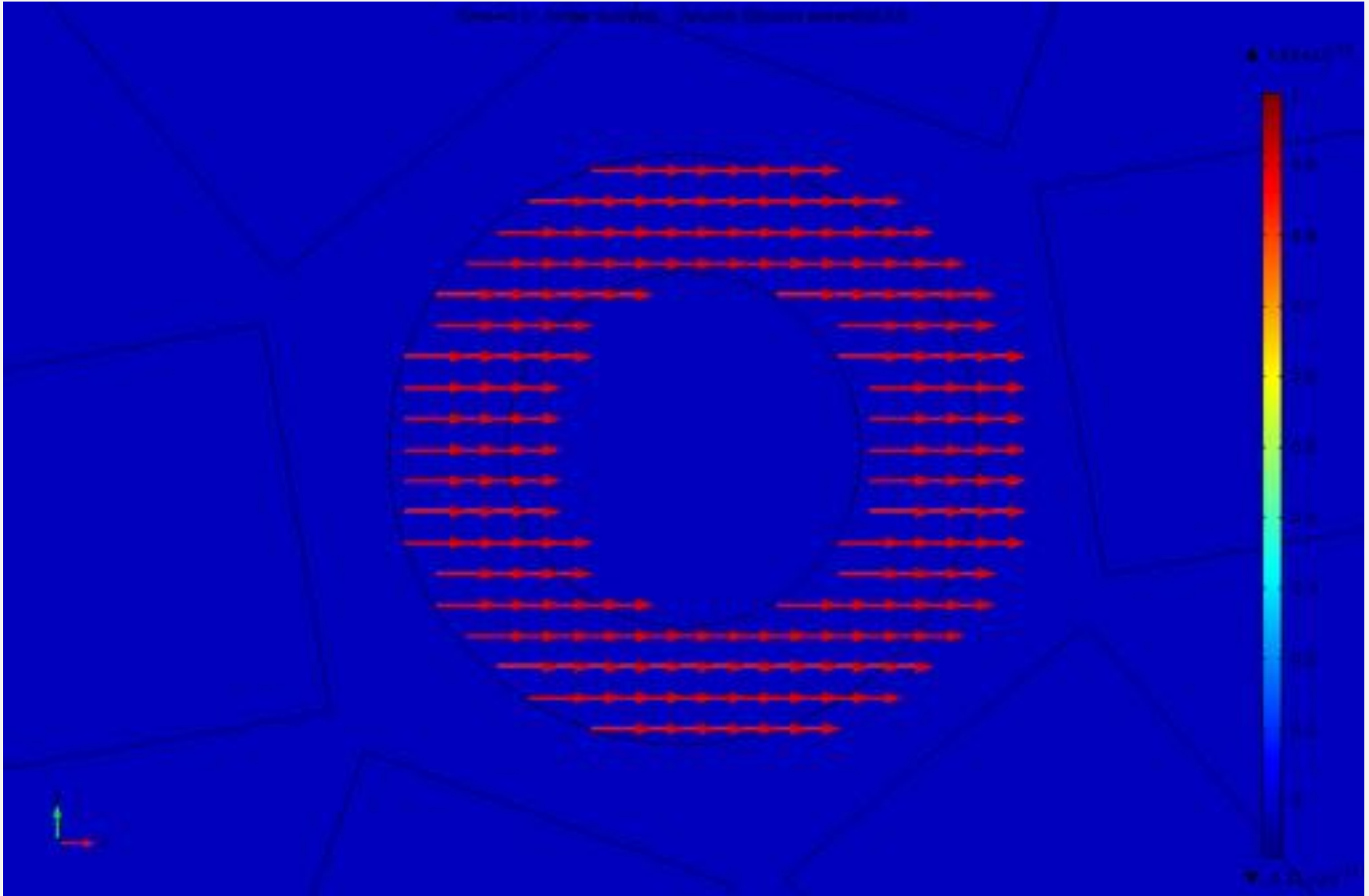
Red Blood Cell



500 nm



# Model of 360 Rotation

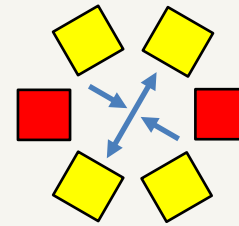
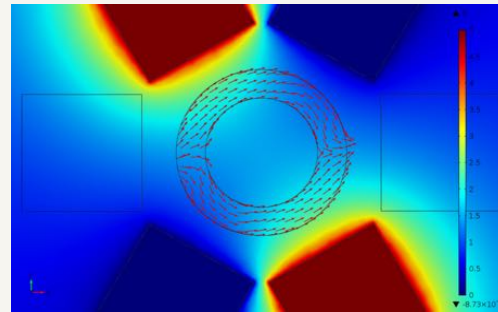
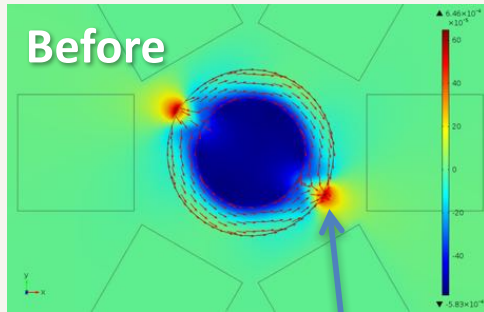


Liang .. Carman, Journal of Applied Physics, Vol. 118, Iss 17, Nov 2015

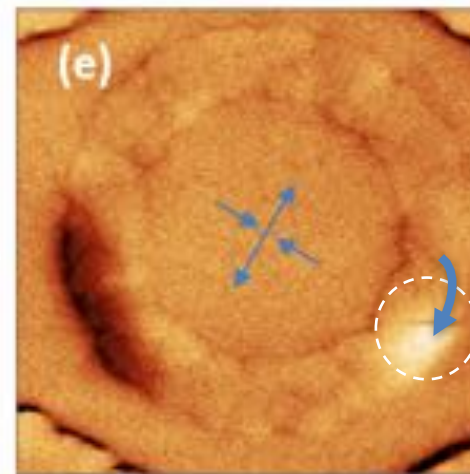
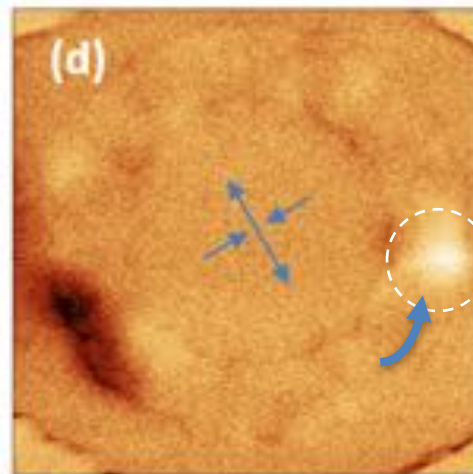
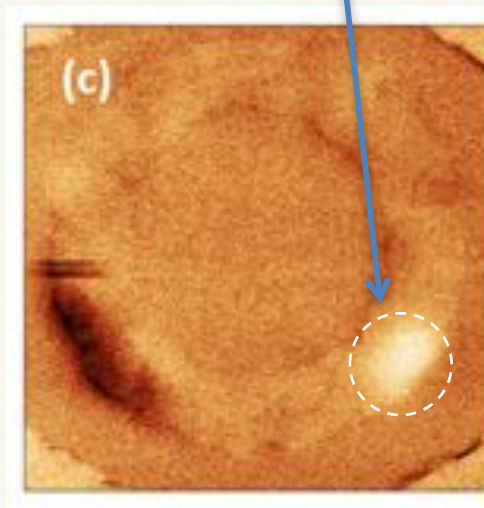


# Surface Electrodes – First results

## Domain wall motion from surface electrodes



Cui, Lynch, Carman et al  
Submitted JAP 2015



- Bidirectional rotation
- Path toward full 360° rotation

Magnetic Force Microscopy Images

Initial state

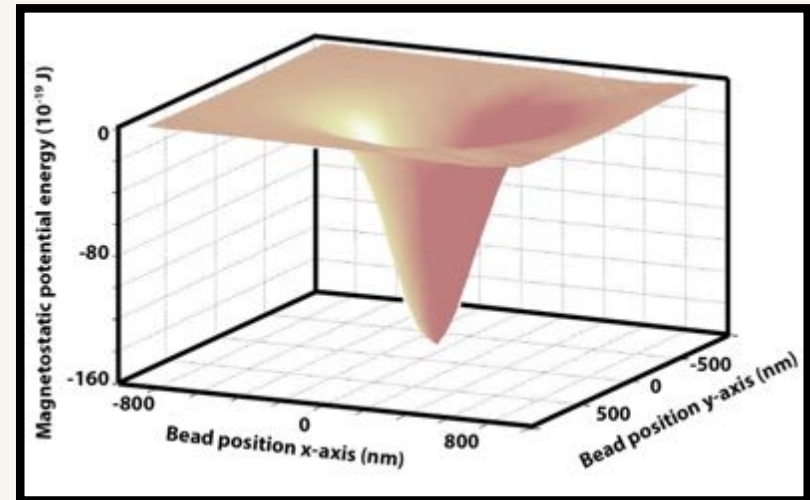
V at A-A

V at B-B

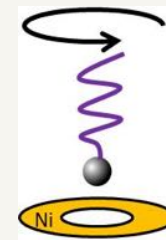
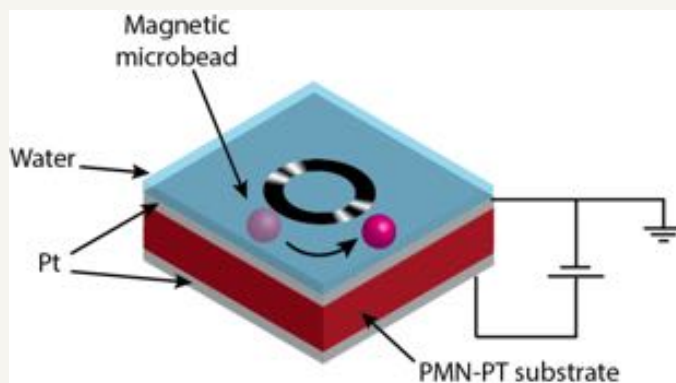
Cui, Lynch.. Carman, APPLIED PHYSICS LETTERS Vol: 107 Iss: 9, AUG 2015



# New Motor Concept: Moving Magnetic Micro-beads



Can we deterministic manipulate a magnetic object coupled to the ring DWs?



Magnetic bead and tail synthesis:  
Collaboration with Sarah Tolbert (UCLA)

Axial rotation

- Rotor
- Rotating tail

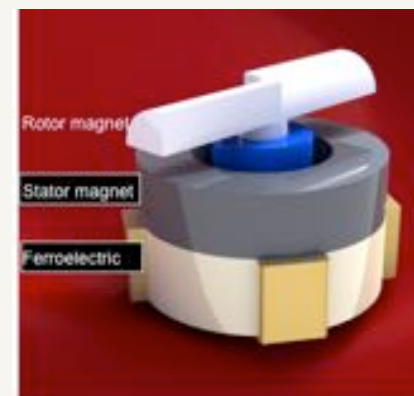
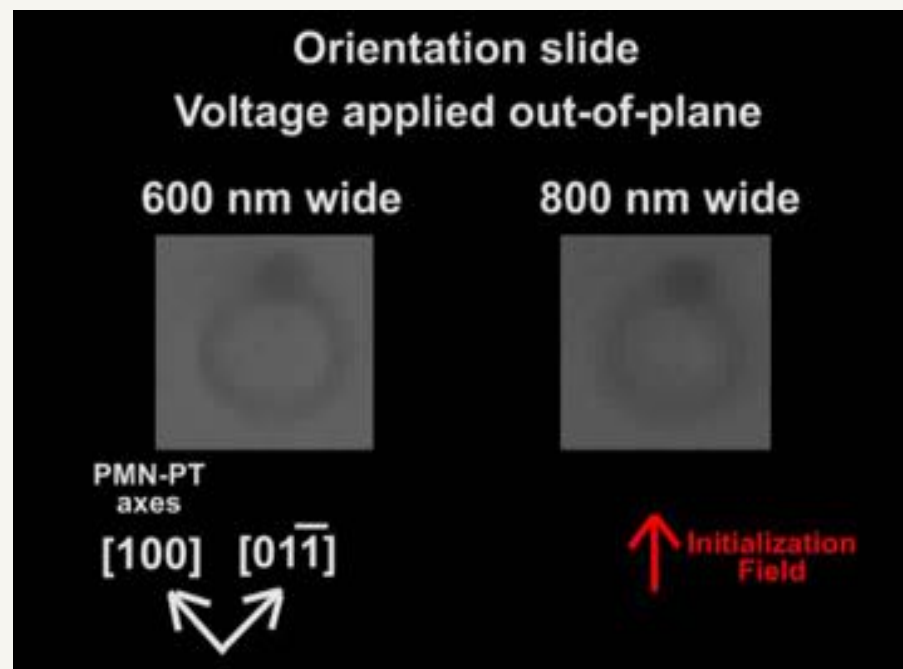


# This can be a Motor

Magnetic Field Rotation  
Rapoport/Beach APL 2012



Electric Field Rotation

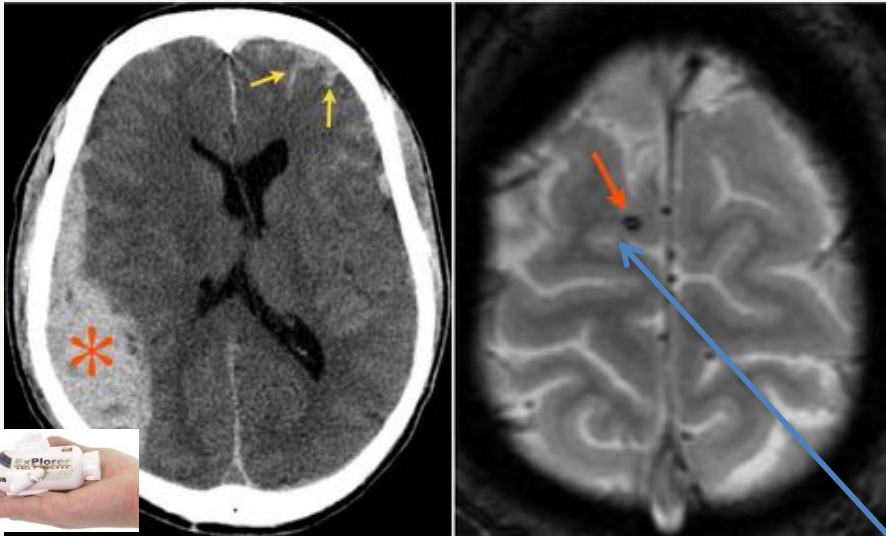


Sohn, Nowakowski, ... Carman, ACS NANO, Vol: 9 Issue: 5 MAY 2015

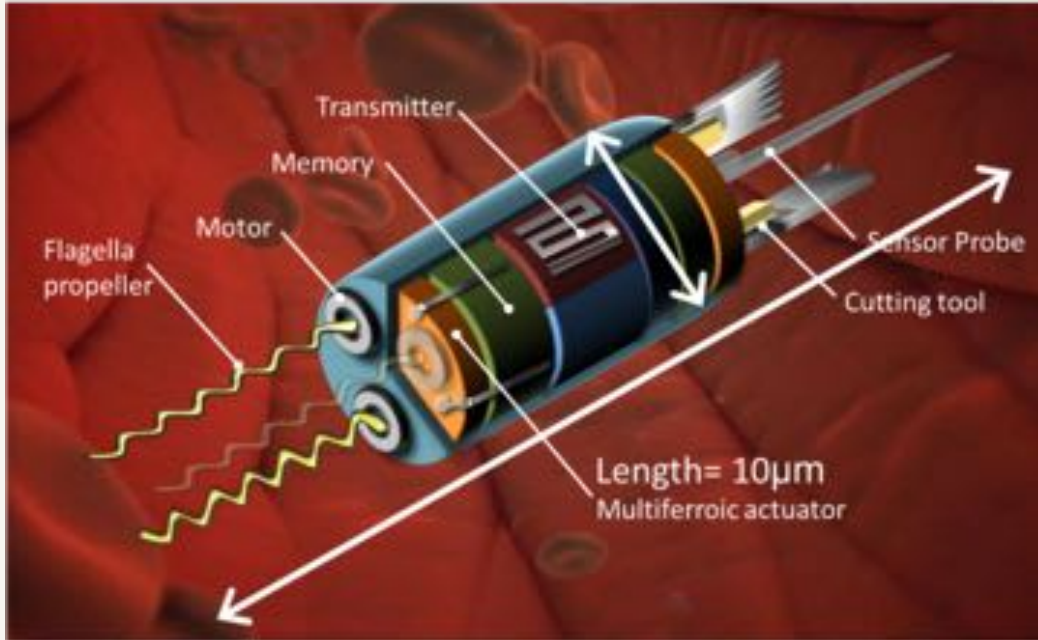
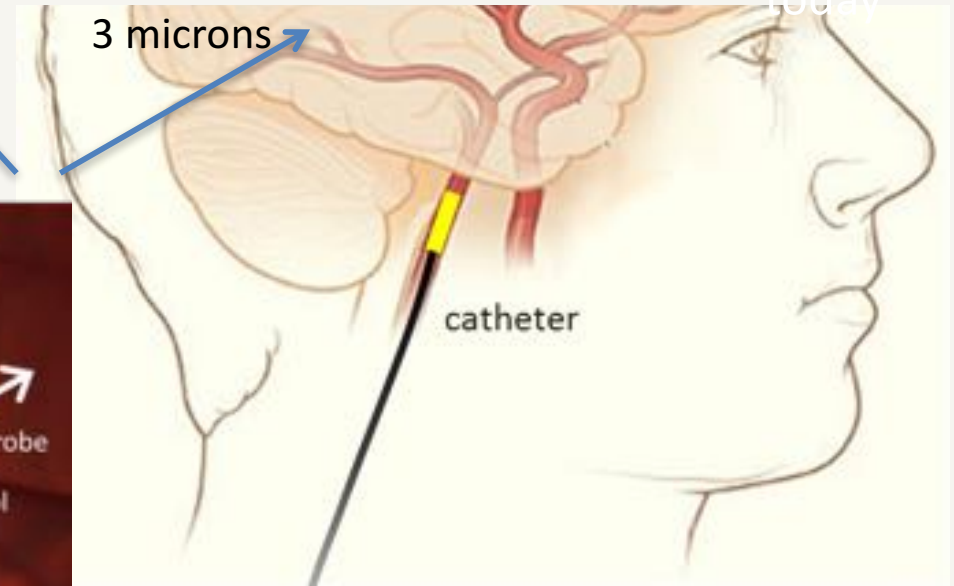




# Enable Other Technologies



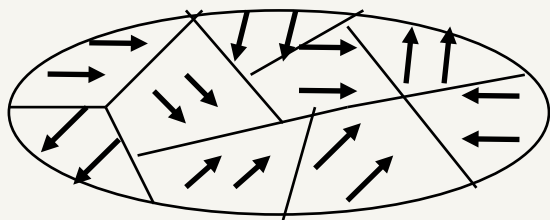
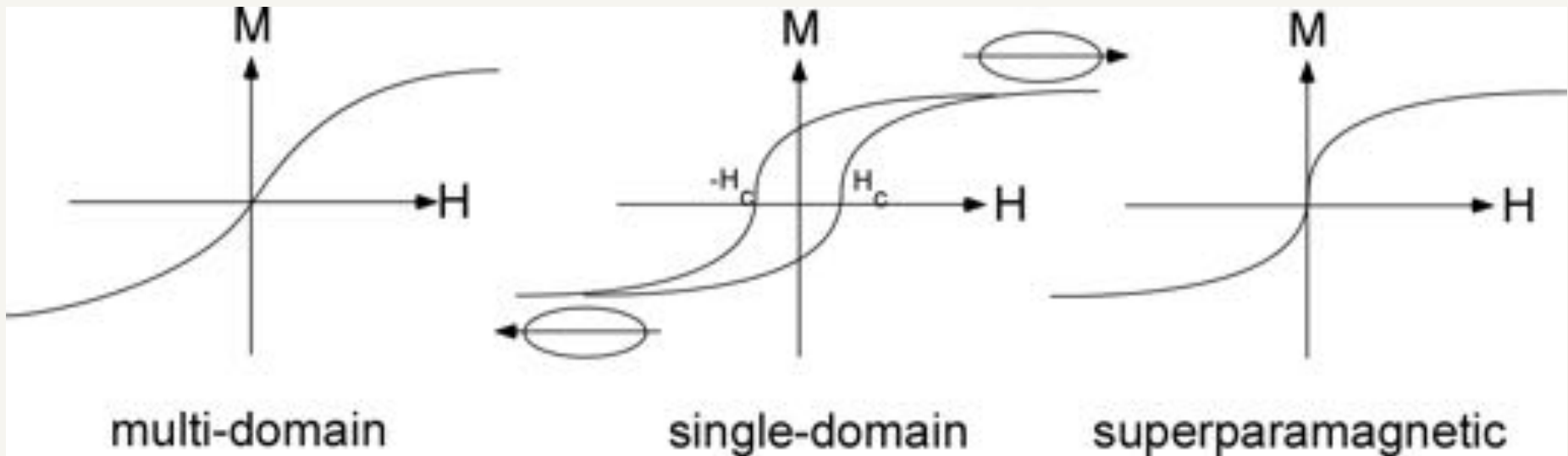
Stanford today



Traumatic Brain Injury (TBI) caused by sudden impact resulting in loss of body function, cognitive abilities, coma, or death (not understood).



# Other Cool New Stuff f(size)



- Low remanence
- Low hysteresis

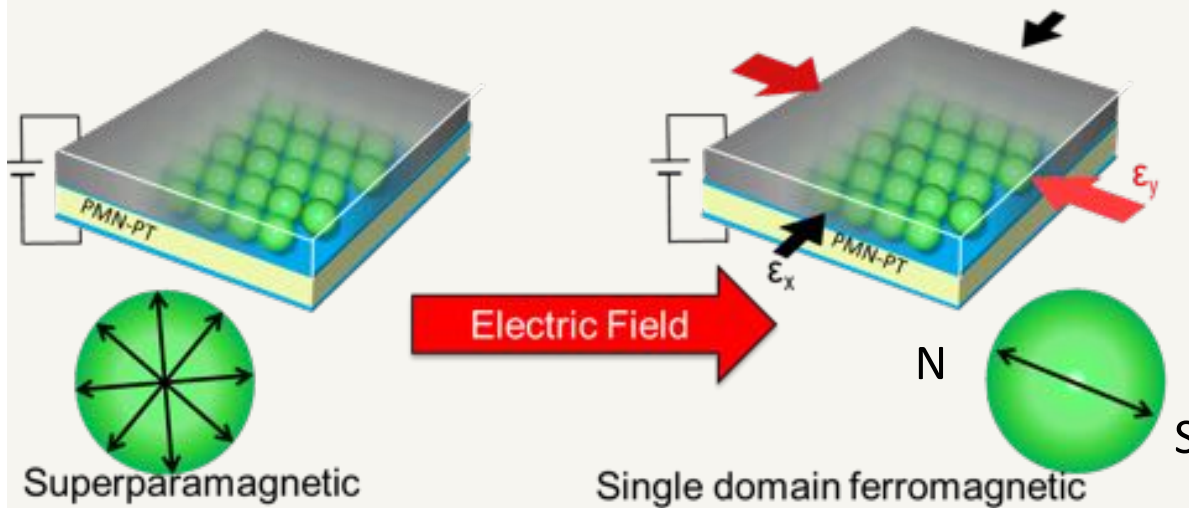


- High remanence
- High hysteresis



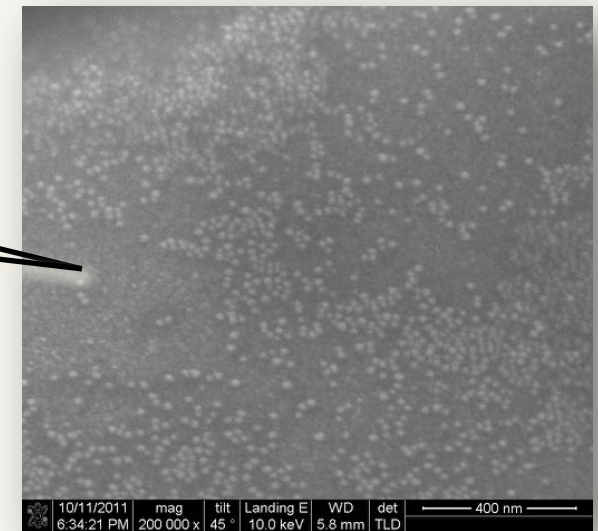
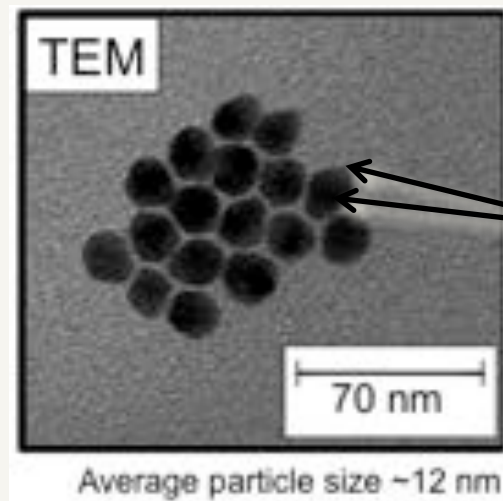
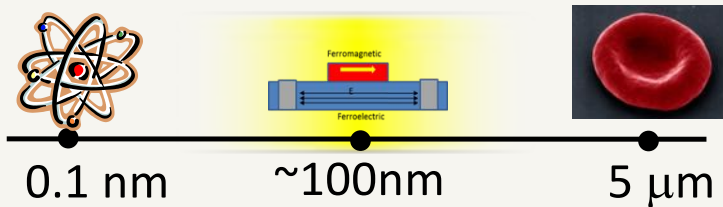
- No remanence
- No hysteresis
- High susceptibility

# Superparamagnetic Control



Collaboration with Sarah Tolbert UCLA

- Ni Nanocrystals thermal decomposition (Tolbert)
- Deposition on 011 PMN-PT
- Single layer of nanocrystals



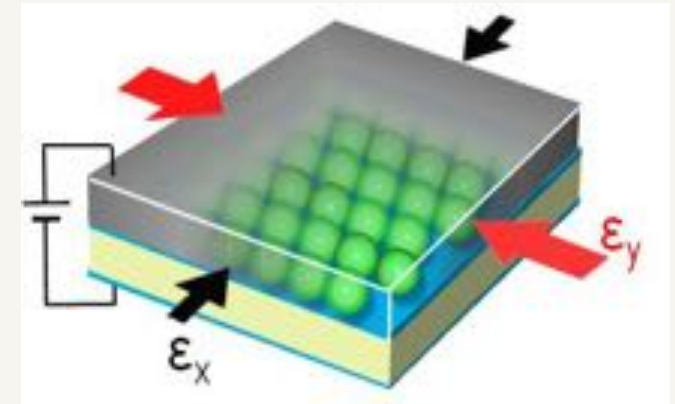
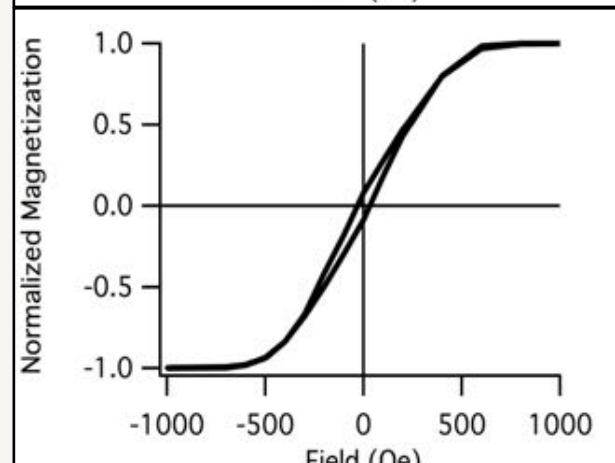
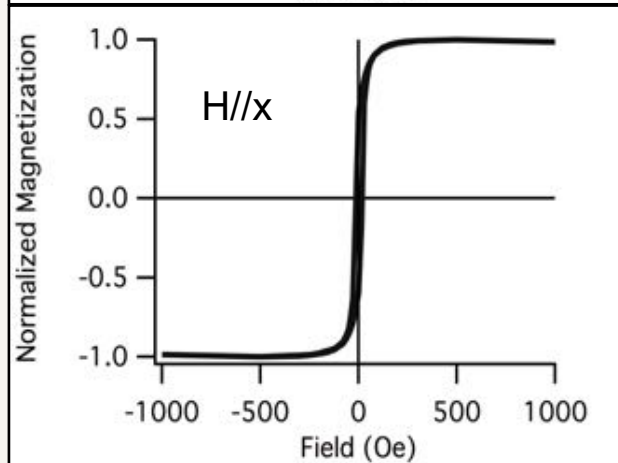
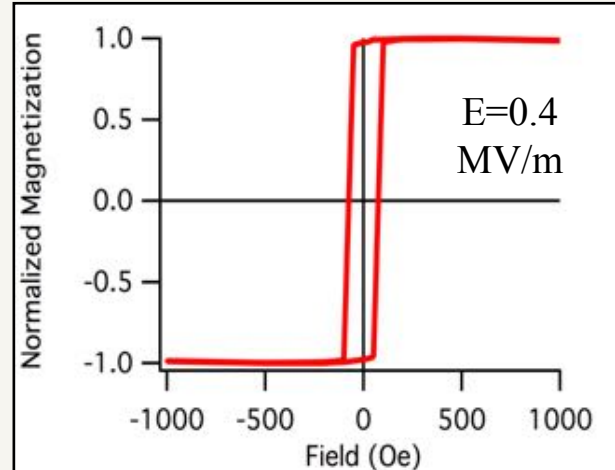
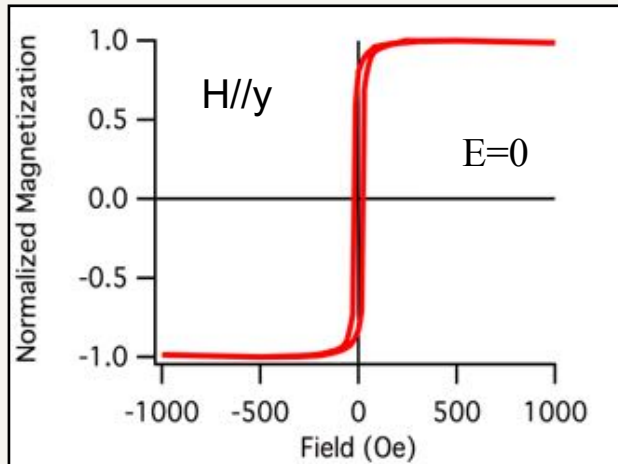
Kim, Schelhas... Carman, "NANO LETTERS, Vol: 13 Iss: 3, MAR 2013



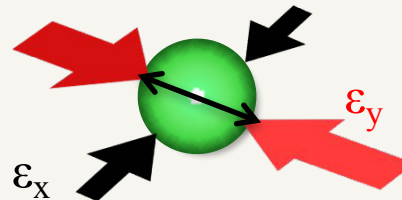
# Electric Control M vs H (RT)

Superparamagnetic

Single Domain

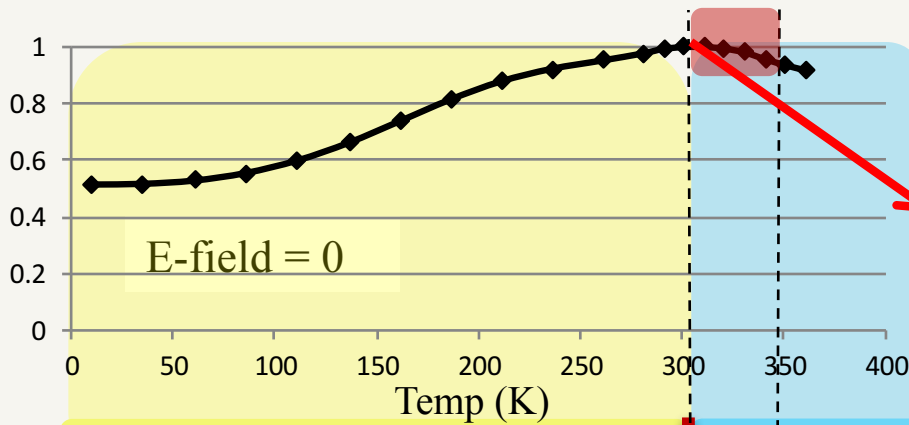


- E field turns on stable single domain
- $H_c$  increased by  $\sim 100$  Oe
- $H_a$  increased to  $\sim 600$  Oe



# ZFC Electric Control $T_B$

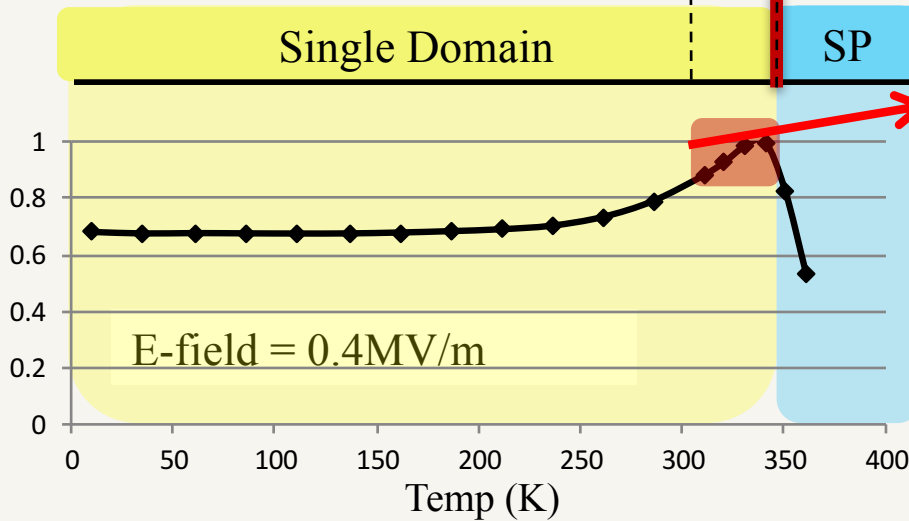
Magnetic Moment



Single Domain

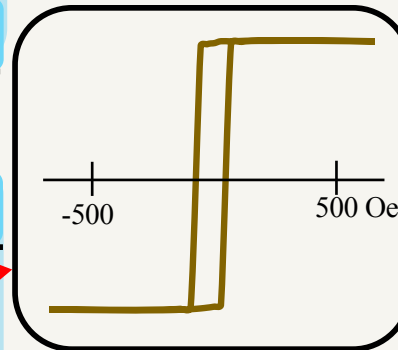
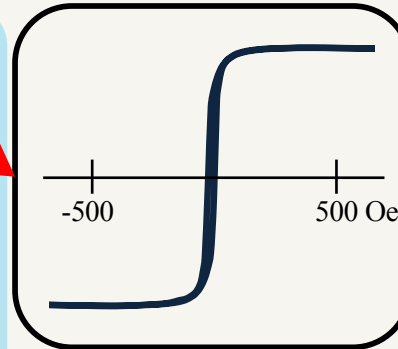
SP

Magnetic Moment

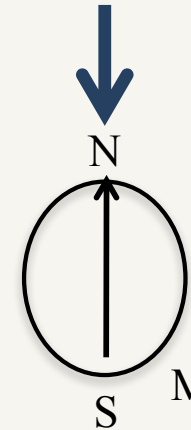
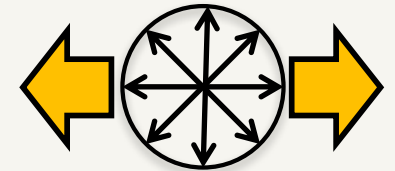


Single Domain

SP



Superparamagnetic

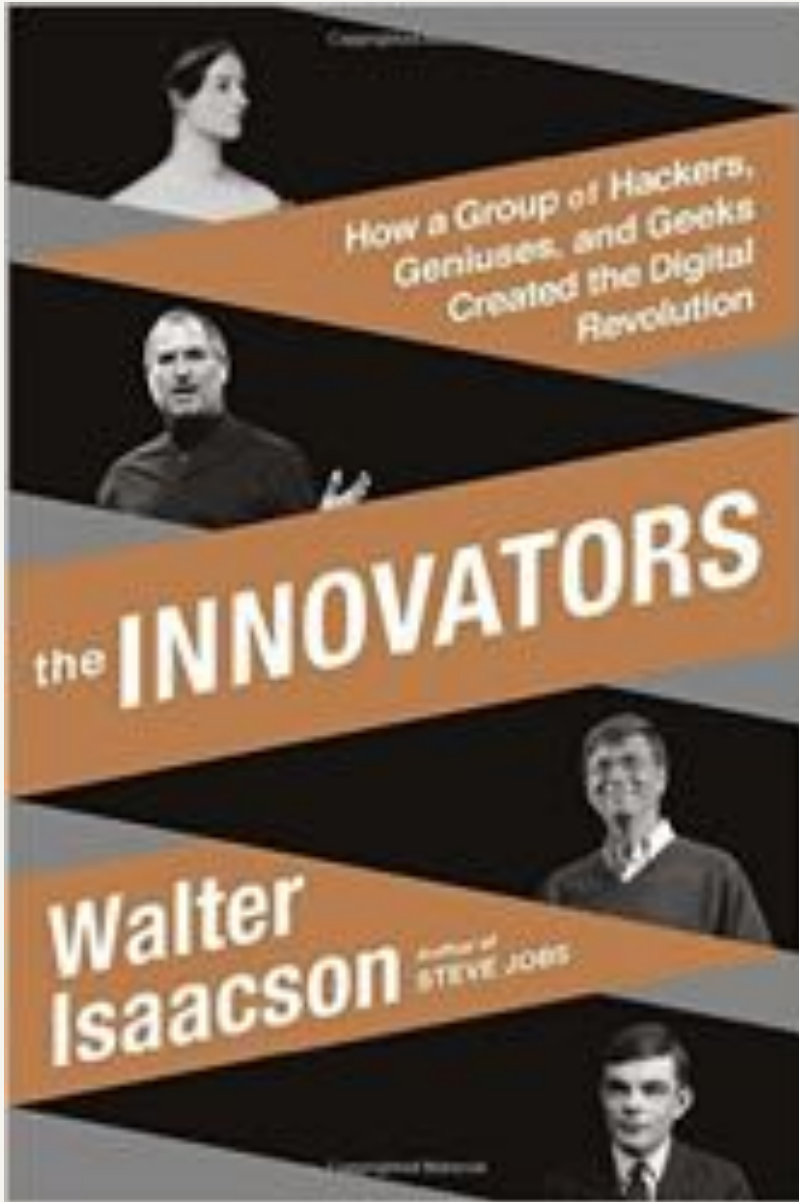


Magnetic

- Blocking temperature shifted by  $\sim 40\text{K}$
- Electric field off, superparamagnetic
- Electric field on, single domain



# Critical Mass



Computers developed because multiple people solved different hard problems – critical mass

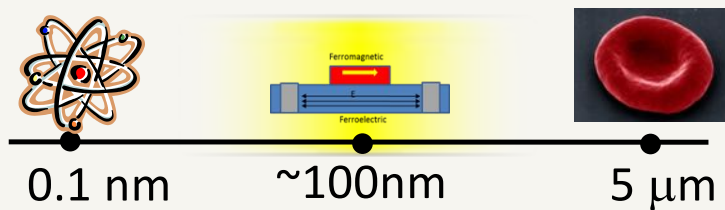
Problems being solved were by groups of individuals - collaboration

Now is the time for a breakthrough in control of magnetism in the small scale – *Future is now*

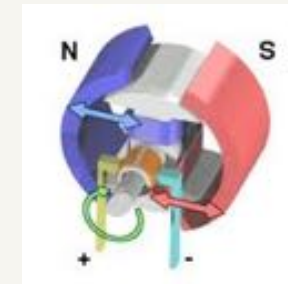
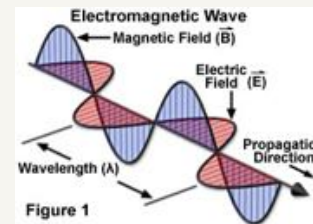


# Summary

- Nanoscale multiferroics control magnetization small scale
  - Efficiency/ Order of magnitude better
- Modeling needed to guide concepts, **must have**
- Testing of concepts challenging, small scale
- Application memory, motors and **much more**
  - Other just cool stuff – Future of miniature electromagnetics



Antenna



EM Motor



# Thanks to Students & Research Scientists

- Josh Hockel
- Scott Keller
- Paul Nordeen
  
- Hyungsuk Kim
- Cheng-Yen Liang
- Chin-Jui Ray Hsu
  
- Tao Wu



PEEM --M. Klau & Frithjof Nolting et al Johannes Guenberg & Paul Scherrer  
PEEM – R. Candler & J. Bokor UCLA & UCB  
Superparamagnetic – S. Tolbert UCLA





# TANMS ERC is seeking new Industry Partners

“We have a new way to control magnetism, in the small scale, that we think will CHANGE the world.”

**TANMS is currently seeking new Industry Partners to collaborate with and to join its industrial advisory board!**

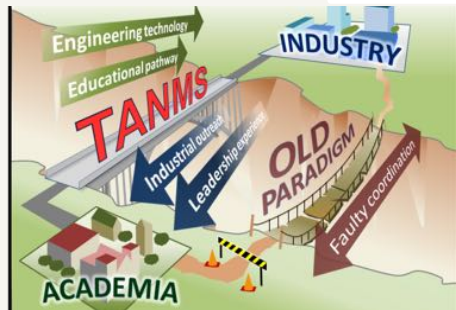
(Companies with an interest in Nanoscale Multiferroic applications in Memory, Antennas, Motors, Materials, and Modeling)



Please contact us if interested in learning more at:  
<https://sites.google.com/a/tanms-erc.org/tanms-industry/home>



Tom Normand  
Director of Industrial Relations  
[tnormand@tanms.ucla.edu](mailto:tnormand@tanms.ucla.edu)  
310-825-7855



Thank You and Please Join Us!

